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(54) **Title:** TALBOT IMAGING DEVICES AND SYSTEMS

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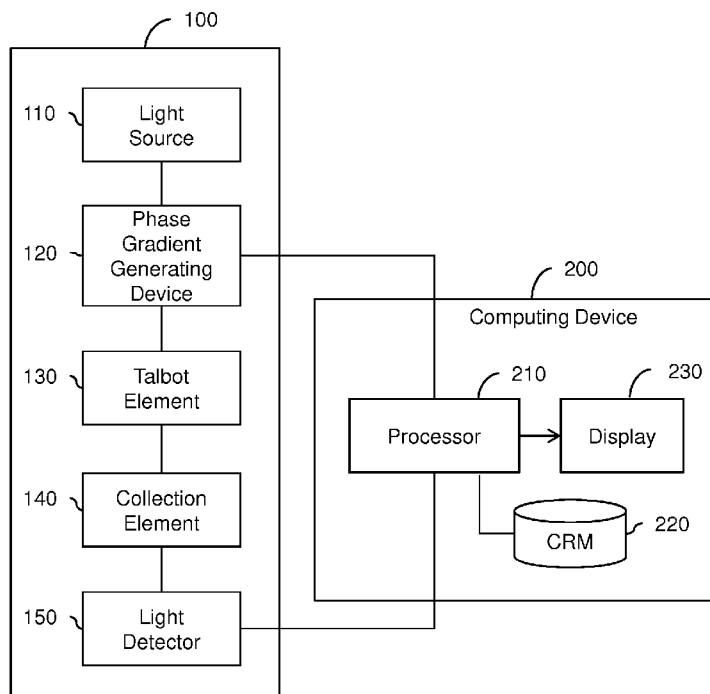


FIG. 1

(57) **Abstract:** A Talbot imaging system comprising a Talbot element, a phase gradient generating device, a light detector, and a processor. The Talbot element repeats a Talbot image at a distance from the Talbot element. The phase gradient generating device scans the Talbot image at a plane at the distance from the Talbot element by incrementally changing a phase gradient of a light field incident the Talbot element. As the Talbot image is scanned, the light detector captures time varying data associated with light altered by an object located at the distance from the Talbot element. The processor reconstructs an image of the object based on the time-varying light data.



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**TALBOT IMAGING DEVICES AND SYSTEMS****CROSS-REFERENCES TO RELATED APPLICATIONS**

**[0001]** This is a non-provisional application of, and claims priority to, U.S. Provisional Patent Application No. 61/450,718 entitled “Fluorescence/Bright Field Talbot Microscope,” filed on March 9, 2011. This provisional application is hereby incorporated by reference in its entirety for all purposes.

**[0002]** This non-provisional application is related to the following co-pending and commonly-assigned patent applications, which are hereby incorporated by reference in their entirety for all purposes:

- U.S. Patent Application No. 12/903,650 entitled “Holographically Illuminated Imaging Devices” filed on October 13, 2010.

## BACKGROUND OF THE INVENTION

[0003] Embodiments of the present invention generally relate wide field-of-view, high resolution imaging devices. More specifically, certain embodiments relate to Talbot imaging (Ti) devices and Ti systems for wide field-of-view, high-resolution bright field and fluorescence imaging used in areas such as, for example, microscopy and photography.

[0004] Optical microscopy is an important tool used in biological and clinical research. The design of optical microscopy has changed very little until a recent effort to miniaturize the microscope on an imaging sensor. Examples of recent developments in on-chip microscopes can be found in Coskun, A. F., Sencan, I., Su, T. W., and Ozcan, A., "*Wide-field lensless fluorescent microscopy using a tapered fiber-optic faceplate on a chip*," Analyst (2011) ("*Coskun*"); Cui, X. Q., Lee, L. M., Heng, X., Zhong, W. W., Sternberg, P. W., Psaltis, D., and Yang, C. H., "*Lensless high-resolution on-chip optofluidic microscopes for Caenorhabditis elegans and cell imaging*," Proceedings of the National Academy of Sciences of the United States of America 105, pp. 10670-10675 (2008); Heng, X., Erickson, D., Baugh, L. R., Yaqoob, Z., Sternberg, P. W., Psaltis, D. and Yang, C. H., "*Optofluidic microscopy - a method for implementing a high resolution optical microscope on a chip*," Lab on a Chip 6, pp. 1274-1276 (2006); Pang, S., Cui, X. Q., DeModena, J., Wang, Y. M., Sternberg, P., and Yang, C. H. "*Implementation of a color-capable optofluidic microscope on a RGB CMOS color sensor chip substrate*," Lab on a Chip 10, pp. 411-414 (2010); and Zheng, G. A., Lee, S. A., Yang, S., and Yang, C. H., "*Sub-pixel resolving optofluidic microscope for on-chip cell imaging*," Lab on a Chip 10, pp. 3125-3129 (2010), which are hereby incorporated by reference in their entirety for all purposes.

[0005] Fluorescence is an important optical readout mode in microscopy because it can be much more sensitive and specific than absorbance and reflectance, as discussed in Tsien, R. Y., Ernst, L., and Waggoner, A., "*Fluorophores for Confocal Microscopy: Photophysics and Photochemistry*," Handbook Of Biological Confocal Microscopy, pp. 338-352 (2006), which is hereby incorporated by reference in its entirety for all purposes. Many on-chip microscopes cannot achieve the optical resolution in fluorescence imaging comparable to that achievable by a convention microscope.

## BRIEF SUMMARY OF THE INVENTION

[0006] Embodiments of the present invention relate to a Ti system a Ti device with a Talbot element, a phase gradient generating device, a light detector, and a processor. The Talbot element repeats a Talbot image (e.g., array of focal spots) at a plane at a distance from itself based on the Talbot effect. A small linear phase gradient change of the incident light field can induce a relatively large lateral translational shift of the Talbot image. The phase gradient generating device scans the Talbot image over an object at the plane by incrementally changing the phase gradient of the incident light field over time. As the Talbot image is scanned, the light detector captures time varying data associated with the light altered by the object. The processor constructs an image of the object based on the time varying data. The Ti device may also include a collection element located between the light detector and the Talbot element to pass emissions and reject excitation light to the light detector. In this case, the processor can construct a fluorescence image based on the time varying data.

[0007] The Talbot effect is a self-imaging effect of certain patterned and some periodic structures, as described in Talbot, H. F., "*LXXVI. Facts relating to optical science. No. IV*," Philosophical Magazine Series 3 9, pp. 401-407 (1836). The patterned image is repeated at regular distances away from the Talbot element. The distance between the repeated images is called a Talbot distance ( $l_t$ ). For a square grid pattern, the Talbot distance  $l_t = 2d^2/\lambda$ , where  $d$  is the pattern period and  $\lambda$  is the wavelength of the incident light, as described in Montgomery, W. D. "*Self-Imaging Objects of Infinite Aperture*," J. Opt. Soc. Am. 57, pp. 772-775 (1967). The Talbot effect can be used as an illumination source, and also used to detect the phase information from a sample, as discussed in Lohmann, A. W. and Silva, D. E. "*An interferometer based on the Talbot effect*," Optics Communications 2, pp. 413-415 (1971). Further research shows sensitivity of the Talbot effect (Talbot image) to the phase change by a sample can be used in X-ray DIC and dark field imaging of the sample, as described in Pfeiffer, F., Bech, M., Bunk, O., Kraft, P., Eikenberry, E. F., Brönnimann, C., Grünzweig, C. and David, C. "*Hard-X-ray dark-field imaging using a grating interferometer*," Nature Materials 7, pp. 134-137 (2008) and in Pfeiffer, F., Weitkamp, T., Bunk, O. and David, C., "*Phase retrieval and differential phase-contrast imaging with low-brilliance X-ray sources*," Nature Physics 2, pp. 258-261 (2006). The cited references in this paragraph are hereby incorporated by reference in their entirety for all purposes.

**[0008]** One embodiment is directed to a Talbot imaging device comprising a Talbot element and a phase gradient generating device, a light detector, and a processor. The Talbot element repeats a Talbot image at a distance from the Talbot element. The phase gradient generating device scans the Talbot image (e.g., array of focal spots) at a plane at the distance from the Talbot element by incrementally changing a phase gradient of a light field incident the Talbot element. The Talbot imaging device may also include a light detector that captures time varying data as the Talbot image is scanned. The time varying data is associated with light altered by an object located at the distance from the Talbot element. The Talbot imaging device may also include a processor that can reconstruct an image of the object based on the time-varying light data.

**[0009]** Another embodiment is directed to a Talbot imaging system comprising a Talbot image device and a processor. The Talbot imaging device comprises a Talbot element, a phase gradient generating device, and a light detector. The Talbot element repeats a Talbot image at a distance from the Talbot element. The phase gradient generating device scans the Talbot image by incrementally changing a phase gradient of a light field incident the Talbot element. As the Talbot image is scanned, the light detector captures time-varying light data associated with light altered by an object located at the distance from the Talbot element. The processor reconstructs an image of the object based on the time-varying light data.

**[0010]** Another embodiment is directed to a method of imaging using a Talbot imaging system. The method incrementally changes a phase gradient of a light field incident a Talbot element to scan a Talbot image at a plane at a distance from the Talbot element. The method also receives light altered by an object located at the plane. The method also generates time varying data based on the light received by the light detector. The method also constructs an image of the object based on the time varying light data.

**[0011]** These and other embodiments of the invention are described in further detail below.

## BRIEF DESCRIPTION OF THE DRAWINGS

[0012] **FIG. 1** is a schematic diagram of components of a Ti system, according to embodiments of the invention.

[0013] **FIG. 2** is a side view of components and partial components of a Ti system of a first configuration, according to embodiments of the invention.

[0014] **FIG. 3** is a side view of components and partial components of a Ti system of a second configuration, according to embodiments of the invention.

[0015] **FIG. 4** is a side view of components and partial components of a Ti system of a third configuration, according to embodiments of the invention.

[0016] **FIG. 5** is a sensor floor plan used in a direct readout mode, according to an embodiment of the invention.

[0017] **FIG. 6** is a reconstruction schematic used in a direct readout mode, according to an embodiment of the invention.

[0018] **FIG. 7** is a sensor floor plan used in a monitored readout mode, according to an embodiment of the invention.

[0019] **FIG. 8** is a reconstruction schematic used in a monitored readout mode, according to an embodiment of the invention.

[0020] **FIG. 10** is a block diagram of subsystems that may be present in the Ti system 10, according to embodiments of the invention.

## DETAILED DESCRIPTION OF THE INVENTION

[0021] Embodiments of the present invention will be described below with reference to the accompanying drawings. Some embodiments include a Ti system having a Ti device and a processor. The Ti device includes a Talbot element, a phase gradient generating device, and a light detector. The Talbot element repeats a Talbot image (e.g., array of focal spots) at a plane at a distance of an integer multiple of a half Talbot distance,  $nl/2$ , from itself. A small linear phase gradient change of the incident light field can induce a relatively large lateral translational shift of the Talbot image. The phase gradient generating device can scan the Talbot image over an object at the plane by changing the phase gradient of the light field incident the Talbot element over time. As the Talbot image is scanned over the object, the light detector captures time varying light data associated with light altered by the object. The processor receives one or more signals with the time varying light data from the light detector and reconstructs an image of the object based on the time-varying light data. In fluorescence imaging embodiments, the Ti device also includes a collection element between the light detector and the Talbot element to pass emissions and reject excitation light.

[0022] Embodiments of the invention provide one or more technical advantages. An advantage of embodiments is large field-of-view imaging. In embodiments, the field-of-view may be determined based on the size of the Talbot element (e.g., plate size) and the size of the light detector. In some cases, the Talbot element size and size of the light detector are on the order of centimeters, which may be 100 times larger than the field-of-view of a conventional microscope. Another advantage of embodiments over conventional methods may be a faster scan speed in performing a full field scan and a faster imaging time. Embodiments use multiple excitation spots which allow for a faster scan speed compared with conventional confocal and other scanning optical microscopy that use an objective lens. In comparison with conventional confocal microscopy applying a Nipkow disk to generate multiple excitation spots, embodiments of the invention can provide a faster scan speed since a smaller phase gradient is needed to perform a full field scan. Also, the field-of-view in conventional confocal microscopes is typically less than  $1\text{mm} \times 1\text{mm}$ . To achieve a large field-of-view of around  $1\text{cm} \times 1\text{cm}$  in a confocal microscope, a translational stage is needed. Embodiments of the invention eliminate the need for a translational stage and the time needed for stage movement, which can improve imaging time. Another advantage of embodiments may be improved uniformity of the image over conventional scanning microscope methods. The Talbot element homogenizes the input beam intensity in the repeated intensity patterns

(Talbot images) so that the focal spots at the plane at the distance of an integer multiple of a half Talbot distance,  $nl_{t,2}$ , is more uniform than the original pattern throughout the field-of-view. Also the small scanning phase gradient will induce less intensity variation of the excitation.

**[0023] I. Ti System**

**[0024] FIG. 1** is a schematic diagram of components of a Ti system **10**, according to embodiments of the invention. The Ti system **10** includes a Ti device **100** and a computing device **200** in electronic communication with the Ti device **100**.

**[0025]** The Ti device **100** includes a light source **110**, a phase gradient generating device **120**, a Talbot element **130**, a collection element **140**, and a light detector **150**. The light source **110** is in communication with the phase gradient generating device **120** to provide coherent light to the phase gradient generating device **120**. In other embodiments, the light source **110** may be separate from the Ti device **100**. The phase gradient generating device **120** is in communication with the Talbot element **130** to provide an incident light field to the Talbot element **130**. An intensity pattern (Talbot image) is repeated at distances of integer multiples of a half Talbot distance ( $l_{t,2}$ ),  $1l_{t,2}$ ,  $2l_{t,2}$ ,  $3l_{t,2}$ , ...,  $nl_{t,2}$ , away from the Talbot element **130**. The phase gradient generating device **120** can controllably change the phase gradient of the incident light field to the Talbot element **130** to scan the Talbot image over an object. The object is located at a plane at a distance of an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$ , away from the Talbot element **130**. In one case, the phase gradient generating device **120** can sweep the phase gradient from 0 to  $k$  in both X-tilt and Y-tilt directions of the plane to scan the Talbot image (e.g., array of focal spots) from 0 to  $nl_{t,2} \times k$  in both X and Y lateral directions of the plane. The collection element **140** is in communication with the Talbot element **130** to collect or otherwise differentiate (e.g., filter) the light signal of interest from the Talbot element **130** as may or may not be altered by the object. The light detector **150** is in communication with the collection element **140** to receive the light signal of interest collected or otherwise differentiated by the collection element **140** as the Talbot image is scanned over the object.

**[0026]** The computing device **200** includes a processor **210**, a computer readable medium (CRM) **220**, and display **230**. The display **230** and CRM **220** are in electronic communication with the processor **210**. The display **230** is in electronic communication with

the processor **210** to receive image data and other data for display. The processor **210** is in electronic communication with the CRM **220** to retrieve/store code with instructions for completing functions of the Ti system **10**. The processor **210** is in electronic communication with the light detector **150** to send and/or receive signals. For example, the processor **210** may send a first trigger signal to start image acquisition and/or may receive a handshake signal from the light detector **150** once acquisition is complete. As another example, the processor **210** may receive signal(s) from the light detector **150** with time varying light data and other related data associated with the acquired images. The processor **210** is also in electronic communication with the phase gradient generating device **120** to send/receive signals. For example, the processor **210** may synchronize the phase generating with the sensor acquisition by sending a second trigger signal to the phase gradient generating device **120** to start phase generating at the same time the first trigger signal is sent to the light detector **150** to start acquisition. The processor **210** may also send a stop signal to the phase gradient generating device **120** to stop phase generating after receiving the handshake signal from the light detector **150**. In other embodiments, the phase gradient generating device **120** and/or light detector **150** may not be in communication with the processor **210**. For example, the light detector **150** may be configured to continuously acquire images after being started by a user and/or the phase gradient generating device **120** may continuously phase generate after being started by the user.

[0027] In an exemplary operation, an object being imaged is located between the collection element **140** and the Talbot element **130**, at a plane that is a distance away from the Talbot element **130** that is an integer multiple of a half Talbot distance,  $nl_{t,2}$  ( $n=1, 2, 3$ , etc.). The processor **210** sends a first trigger signal to the phase gradient generating device **120** to start phase generating and a second trigger signal to the light detector **150** to start image acquisition. The phase gradient generating device **120** starts generating an incident light field provided to the Talbot element **130**. A Talbot image (e.g., array of focal spots) is repeated at a distance of an integer multiple of a half Talbot distance,  $nl_{t,2}$ , away from the Talbot element **130**. The phase gradient generating device **120** controls the phase gradient of the light field to achieve a full field scan of the Talbot image over the object being imaged. For example, the phase gradient generating device **120** may sweep the phase gradient from 0 to  $k$  in both X-tilt and Y-tilt directions to scan the Talbot image from 0 to  $nl_{t,2} \times k$  in both X and Y directions of the plane at a distance of  $nl_{t,2}$  from the Talbot element **130**. The object alters the light from the scanning Talbot image. The collection element **140** receives light

altered and unaltered by the object as the Talbot image is scanned over the object. The collection element **140** collects or otherwise differentiates the light of interest from the light received. As the Talbot image is scanned over the object, the light detector **150** receives light of interest from the collection element **140** and records time varying light data (e.g., intensity data) of altered and/or unaltered light. After the light detector **150** completes the acquisition cycle, it sends a handshake signal to the processor **210**. The processor **210** sends a stop signal to the phase gradient generating device **120** and the phase gradient generating device **120** stops phase generating. The processor **210** receives a signal or signals with the time varying light data from the image sensor **150** and constructs one or more bright field and/or fluorescence images of the object **300** based on the time varying light data and other data received. The processor **210** can display the one or more images on the display **230**.

[0028] A light source **110** can refer to any suitable device or combination of devices that can provide spatially coherent incident light **112** (as shown in **FIGS. 2, 3, and 4**) to the phase gradient generating device **120**. Some examples of suitable devices include a laser, narrow band LED, and a filtered line of some broadband light source. Suitable devices are commercially available. The light source **110** can be placed in any suitable location. The light source **110** may be a component of the Ti device **100**, or may be separate from the Ti device **100**. The incident light **112** (as shown in **FIGS. 2, 3, and 4**) to the phase gradient generating device **120** may have light properties (wavelength ( $\lambda$ ), phase, intensity, etc.) with any suitable values.

[0029] A phase gradient generating device **120** can refer to a suitable device(s), structure(s), or suitable combination thereof capable of controlling the change of the phase gradient of light field incident to the Talbot element **130**. The phase of the incident light field may be linear or any arbitrary phase. Some examples of suitable devices/structures include arrays (one-dimensional or two-dimensional) such a Spatial Light Modulator (SLM) array having a piezo-mirror array, a deflection mirror array, a liquid crystal array, and other suitable arrays. The dimensions of the array used may be any suitable value (e.g.,  $10 \times 10$ ,  $100 \times 100$ ,  $200 \times 10$ , etc). Another example of suitable structures/devices that may be included in a phase gradient generating device **120** are beam deflectors. Some examples of suitable beam deflectors include polymers or crystals (e.g., Potassium Dihydrogen Phosphate (KDP) crystal, KNT crystal, nematic liquid crystal, wedge/blazed grating, etc.) that use electro-optical effects for beam steering; mechanically controlled beam deflectors (e.g., motors, piezo-actuators, micro-electro-mechanical system (MEMS) mirror, etc.); acoustic

optical deflectors; thermal optical deflectors; hologram deflectors; and other beam deflectors (e.g., electro-wetting cell array). In on-chip embodiments of the Ti device **100**, the phase gradient generating device **120** may be in the form of an on-chip device/structure. Some examples of suitable on-chip devices/structures include the deflection mirror array, liquid crystal array, MEMS mirror, etc.

**[0030]** A Talbot element **130** can refer to any suitable patterned structure or combination of patterned structures capable of creating a light field that repeats the intensity pattern (Talbot image) at distances away from the Talbot element **130** based on the Talbot effect. Some examples of suitable structures include an aperture array, micro-lens array, micro-concave mirror array, phase/amplitude gratings, other patterned diffraction structure, or any suitable combination thereof. The Talbot element **130** may be a periodic structure(s) or may be a non-periodic structure(s). An example of a repeated intensity pattern (Talbot image) is an array of focal spots.

**[0031]** In embodiments, the Talbot element **130** may be a periodic structure (e.g., laterally periodic diffraction structure) or combination of periodic structures. The periodic structure has a pattern that repeats structural elements (e.g., apertures) on a periodic basis according to a period,  $d$ . The periodic structure may be periodic in a single lateral direction or both lateral directions of the Talbot element **130**. The period,  $d$ , may be any suitable value (e.g., 5 microns, 15 microns, 30 microns, 100 microns, etc.). Some examples of suitable periodic structures are a one-dimensional or two-dimensional array of laterally uniformly spaced structures (e.g., 2D aperture grid). The period,  $d$ , of each array is the distance between the uniformly spaced structures. For example, a suitable periodic structure may be a two-dimensional array of uniformly spaced apertures. In embodiments with a periodic Talbot element **130**, the intensity pattern (Talbot image) may repeat at integer multiples,  $nl_{t,2}$ , of a half Talbot distance ( $l_{t,2}$ ). For example, the intensity pattern (Talbot image) may repeat at  $1l_{t,2}$ ,  $2l_{t,2}$ ,  $3l_{t,2}$ , ...,  $nl_{t,2}$ , away from the Talbot element **130**. In an embodiment with a periodic Talbot element **130** in the form of a two-dimensional array of apertures, the Talbot distance,  $l_t = 2d^2/\lambda$  and the half Talbot distance,  $l_{t,2} = d^2/\lambda$ , where  $\lambda$  is the wavelength of the incident light field and  $d$  is the distance between the apertures.

**[0032]** In embodiments, the Talbot element **130** is a periodic structure capable of repeating a Talbot image of an array of focal spots at distances of integer multiples of a half Talbot distance ( $l_{t,2}$ ),  $1l_{t,2}$ ,  $2l_{t,2}$ ,  $3l_{t,2}$ , ...,  $nl_{t,2}$ , away from itself. For example, the Talbot

element **130** may include an aperture array and the Talbot image may be an array of focal spots. If the Talbot element **130** is laterally periodic in both lateral directions, the array of focal spots is a two-dimensional array of focal spots. The geometry of the array of focal spots may correspond to the periodic pattern in the Talbot element **130**. For example, the distance between the focal spots, pitch  $p$ , may correspond to the period,  $d$ , of the periodic pattern of the Talbot element **130**. As another example, the shape and size of the focal spots may correspond to the shape and size of elements (e.g., apertures) in the periodic pattern of a Talbot element **130**. In embodiments, the Talbot element **130** may be designed so that the pitch,  $p$ , distance between focal spots, is larger than the size (e.g., pixel size) of the light detecting elements **152** (as shown in **FIG. 5**) in the light detector **150**. With this design, each light detecting element **152** (as shown in **FIG. 5**) corresponds to a single focal spot and the intensity (e.g., emission intensity) from each focus point can be differentiated. In embodiments, the pitch,  $p$ , between the focal spots is equal to the period,  $d$ , of the periodic pattern of the Talbot element **130**.

[0033] In embodiments, the phase gradient generating device **120** may change, over time during an image acquisition process, the phase gradient of the light field incident the Talbot element **130**. A small linear phase gradient change at the Talbot element **130** may induce a relatively large lateral translational shift of the Talbot image. By changing the phase gradient over time, the phase gradient generating device **120** can scan the Talbot image (e.g., array of focal spots) located at a plane that is at a distance of an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$ , from the Talbot element **130**. During scanning, an object being imaged is located at the plane at the distance,  $nl_{t,2}$ , from the Talbot element **130**. During scanning, the phase gradient generating device **120** may change the phase gradient over time to scan the Talbot image over the object located at the plane at a distance,  $nl_{t,2}$ , from the Talbot element **130**. The phase gradient generating device **120** may change the phase gradient in one direction to scan the Talbot image in a single lateral direction of the plane, or change the phase gradient in two orthogonal directions to achieve a full field scan the Talbot image in both lateral directions of the plane. In one embodiment, the phase gradient generating device **120** may achieve a full field scan of the object by sweeping the phase gradient from 0 to  $k$  in two orthogonal directions to scan an Talbot image from 0 to  $nl_{t,2} \times k$  in both X and Y lateral directions of the plane at a distance of  $nl_{t,2}$  from the Talbot element **130**. The scanned distance,  $nl_{t,2} \times k$  in each X and Y direction, may be designed to be at least the distance between the focal spots, or period,  $d$ , of the pattern in the Talbot element **130**.

[0034] A collection element **140** can refer to any suitable structure(s), device(s) or combination thereof capable of collecting or otherwise differentiating the light of interest (e.g., emissions) as may be light altered and unaltered by the object. Some examples of structures/devices include suitable lenses that can collect scattered light, filters, phase structures that can detect phase change, and polarizers that can detect the polarization change. Some examples of suitable filters include wavelength filters capable of differentiating the wavelength such as fluorescence, Phosphorescence, second harmonic generation, two-photon induced photoluminescence filters.

[0035] In embodiments, the collection element **140** includes a filter for passing emissions from excited fluorophores in the object and rejecting (e.g., reflecting or absorbing) excitation light from the Talbot image (e.g., array of focal spots). In these cases, the Ti system **10** may be capable of fluorescence imaging.

[0036] A light detector **150** can refer to a suitable device or combination of devices capable of receiving light, measuring/recording light data associated with the light received, and generating one or more signals with light data. The one or more signals with light data may be in the form of an electrical current from the photoelectric effect. In some cases, the light detector **150** may be in the form of a one-dimensional linear array of a two-dimensional array of discrete light detecting elements **152** (shown in **FIG. 5**) of any suitable size (e.g., 1-10 microns) and any suitable shape (e.g., circular, rectangular, square, etc.). Some examples of suitable devices include a complementary metal oxide semiconductor (CMOS) imaging sensor array, a charge coupled device (CCD), electron multiplying charge coupled device (EMCCD), an avalanche photo-diode (APD) array, a photomultiplier tubes (PMT) array, and a photo-diode (PD) array. These light detectors **160** and others are commercially available. The light detector **150** can be a monochromatic detector or a multi-color detector (e.g., RGB detector).

[0037] Time varying light data can refer to any suitable information related to the light received and measured by the light detector **150**. If the light detector **150** is the form of multiple discrete light detecting elements **152** (as shown in **FIG. 5**), the time varying light data may include suitable information related to the light received and measured by the multiple discrete light detecting elements **152** (as shown in **FIG. 5**) on a time varying basis. In some cases, each light detecting element **152** (as shown in **FIG. 5**) can generate a signal with time-varying light data based on light received and measured by the light detecting

element **152** (as shown in **FIG. 5**). Time-varying light data may include, for example, properties of the light received such as the intensity(ies) of the light, the wavelength(s) of the light, the frequency or frequencies of the light, the polarization(s) of the light, the phase(s) of the light, the spin angular momentum(s) of the light, and/or other light properties associated with the light received by the light detector **150** and/or each light detecting element **152** (as shown in **FIG. 5**). Time varying light data may also include the location of the light detecting element(s) **152** (as shown in **FIG. 5**) receiving the light, the time that the light was received, or other information related to the light received.

[0038] An object **300** (shown in **FIG. 2**) being examined by the Ti system **10** can refer to any suitable entity, such as a biological or inorganic entity. Examples of suitable biological entities include cells, cell components (e.g., proteins, nuclei, etc.), microorganisms such as bacteria or viruses, etc. Although a single object **300** is shown in illustrated embodiments, in other embodiments any suitable number (e.g., 1, 2, 10, 100, 1000, etc.) of objects **300** may be examined by the Ti system **10**. For example, **FIG. 3** shows a Ti system **10** examining three objects **300**.

[0039] In fluorescence imaging embodiments, a fluorescence/phosphorescence dye may be mixed with a specimen having the object **300** being imaged in order to mark or tag portions (e.g., nucleus) of the object **300** (e.g., cell) under investigation with fluorophore(s). A fluorophore can refer to a component of a molecule that causes the molecule to fluorescence or phosphorescence once excited. A fluorophore can absorb energy from excitation light of a specific wavelength(s) and re-emit the energy at a different wavelength(s).

[0040] A computing device **200** can refer to any suitable combination of devices capable of performing computing and controlling functions of the Ti system **10** such as reading out the collected signal(s) from the light detector **150**, synchronizing the functions of different components of the Ti system **10**, reconstructing an image of an object, etc. Some examples of suitable computing devices include a personal computer (desktop, laptop, etc.), a mobile communications device (e.g., smartphone or tablet), or other suitable device. In **FIG. 1**, the Ti system **10** includes the computing device **200**. Alternatively, the computing device **200** can be a separate device from the Ti system **10**.

[0041] A processor **210** can refer to any suitable processing device (e.g., microprocessor) or devices that can execute code stored on the CRM **220** (e.g., memory) to

perform one or more functions of the Ti system **10**. For example, the CRM **220** may include code for: c) code for interpreting light data received in one or more signals from the light detector **150**, d) code for constructing one or more images of an object from the light data, f) code for displaying images on the display **230**, g) and/or any other suitable code for performing functions of the Ti system **10**. The CRM **220** may also include code for performing any of the signal processing or other software-related functions that may be created by those of ordinary skill in the art. The code may be in any suitable programming language including C, C++, Pascal, etc. The processor **210** may be in any suitable location. In **FIG. 1**, the processor **210** is located in the computing device **200**. In another embodiment, the processor **210** may be located in the light detector **150**.

[0042] The display **230** can refer to an suitable device for displaying reconstructed images, light data, and other suitable data. Some examples of suitable displays include a computer monitor, cell phone panel, projection, etc. Suitable displays are commercially available. The display **230** may be a monochromatic or multi-color display. Also, the display may be a two-dimensional or three-dimensional display, etc. In one case, the image display **230** may be capable of displaying multiple views.

[0043] The Ti system **10** may have many different configurations. Three exemplary configurations are described below.

[0044] **A. FIRST CONFIGURATION**

[0045] **FIG. 2** is a side view of components and partial components of a Ti system **10** of a first configuration, according to embodiments of the invention. The Ti system **10** of the first configuration may be used for bright field and/or fluorescence imaging. The Ti system **10** of the first configuration may be fabricated on a chip. The Ti system **10** of the first configuration includes a Ti device **100** and a computing device **200** (as shown in **FIG.1**) in communication with the Ti device **100**.

[0046] In **FIG. 2**, the Ti device **100** includes a light source **110** providing coherent light **112**, a phase gradient generating device **120**, and a portion of a Talbot element **130**. The Ti device **100** also includes a collection element **140** with a filter for passing emission light and rejecting (e.g., reflecting/absorbing) excitation light, a light detector **150** for receiving/measuring light data, and a specimen surface **160** for receiving an object **300** being imaged by the Ti system **10**.

[0047] The phase gradient generating device **120** includes a two-axis MEMS mirror **121**, a quarter-wave plate **123**, and a polarization sensitive beam splitter **124**. The light source **110** provides coherent light **112** in the form of a collimated linear polarized beam incident on the polarization sensitive beam splitter **124**. The polarization sensitive beam splitter **124** reflects the collimated linear polarized beam to a quarter-wave plate **123**. The linear polarized beam is then transformed to a clockwise (or counter clockwise) circular polarized beam by the quarter-wave plate **123**. The circular polarized beam is reflected from the MEMS mirror **121** and changes to a counter clockwise (or clockwise) circular polarized beam. After passing the quarter-wave plate **123** again, the polarization of the beam is transformed back to linear but its direction is perpendicular to the original direction. With this polarization change, the light will then pass the polarization sensitive beam splitter **124** and provide the incident light field to the Talbot element **130**. Suitable two-axis MEMS mirrors **121**, a quarter-wave plates **123**, and polarization sensitive beam splitters **124** are commercially available.

[0048] In **FIG. 2**, the two-axis MEMS mirror **121** includes an outer surface **121(a)**, and a x'-axis and y'-axis (not shown). The x'-axis and y'-axis lie in a plane at the outer surface **121(a)** of the two-axis MEMS mirror **121**. The two-axis MEMS mirror **121** also includes a mechanical tilt angle,  $\beta_x$ , (not shown) in the x'-tilt direction and a mechanical tilt angle,  $\beta_y$ , **121(b)** in the y'-tilt direction. Changing the mechanical tilt angles,  $\beta_x$  and  $\beta_y$  of the two-axis MEMS mirror **121** induces a respective change in the optical tilt angles,  $\theta_x$  and  $\theta_y$ , of the incident field to the Talbot element **130**. A change in the optical tilt angles,  $\theta_x$  and  $\theta_y$ , induces a respective change of the phase gradient  $k_x$  and  $k_y$ , of the incident field to the Talbot element **130**. The relationships can be described as follows:

$$\theta_x = 2 \times \beta_x \quad (\text{Eqn. 1a})$$

$$\theta_y = 2 \times \beta_y \quad (\text{Eqn. 1b})$$

$$k_x = \tan \theta_x = \tan (2\beta_x) \quad (\text{Eqn. 1c})$$

$$k_y = \tan \theta_y = \tan (2\beta_y) \quad (\text{Eqn. 1d})$$

Although the MEMS mirror **121** in the illustrated example is a two-axis MEMS mirror **121**, in other embodiments, the MEMS mirror may be a single axis MEMS mirror **121**.

[0049] The Ti device **100** includes a Talbot element **130** with a two-dimensional microlens array **132** and an aperture layer **133** having a two-dimensional aperture array **134**

aligned with the two-dimensional microlens array **132**. **FIG. 2** illustrates a portion of the Talbot element **130** of the Ti device **100**. The entire Talbot element **130** includes a microlens array **132** and aperture array **134** that may have dimensions of any suitable size (e.g.,  $30 \times 30$ ,  $100 \times 100$ ,  $200 \times 200$ ,  $100 \times 300$ ,  $200 \times 400$ ,  $400 \times 400$ , etc.). In other embodiments, the microlens array **132** and aperture array **134** may be one-dimensional micro-cylindrical arrays or one-dimensional slots array having dimensions of suitable sizes (e.g.,  $100 \times 1$ ,  $200 \times 1$ ,  $300 \times 1$ , etc.).

**[0050]** The portion of the Talbot element **130** shown in **FIG. 2** includes a portion of the entire two-dimensional microlens array **132** of the Talbot element **130**. The portion includes a two-dimensional array with dimensions having a size of  $5 \times 5$ , and having 25 microlenses **132(a)** in two orthogonal directions. The portion of the Talbot element **130** shown in **FIG. 2** also includes a portion of the two-dimensional aperture array **134** of the entire Talbot element **130**. The portion includes a two-dimensional array with dimensions having a size of  $5 \times 5$ , and having 25 apertures **134(a)** in two orthogonal directions.

**[0051]** The two-dimensional microlens array **132** focuses (i.e. condenses) the light from the phase gradient generating device **120** onto the apertures **134(a)** of the two-dimensional aperture array **134**. Focusing the light onto the apertures **134(a)** may increase the efficiency of the Talbot element **130** in some cases.

**[0052]** The aperture layer **133** includes a two-dimensional aperture array **134** and an outer surface **133(a)**. The apertures **134(a)** of the two-dimensional aperture array **134** have a uniform circular shape and a uniform diameter of 0.6 micron. In other embodiments, the apertures **134(a)** may have other suitable shapes and sizes (e.g., 0.2 micron, 0.5 micron, 1 micron, 2 microns, etc.). The aperture size may affect focus quality in some cases.

**[0053]** The two-dimensional microlens array **132** has a uniform period,  $d_1$ , and the two-dimensional aperture array **134**, has a period,  $d_2$ , that matches the period of two-dimensional microlens array **132**. In the illustrated example, the Talbot element **130** has a period,  $d$ , of 30 microns, which corresponds to the matching periods of the two-dimensional microlens array **132** and the two-dimensional aperture array **134**. That is, in this example,  $d = d_1 = d_2 = 30$  microns. In other embodiments, the period of the Talbot element **130**,  $d$ , may have other suitable values such as 5 microns, 15 microns, 100 microns, etc.

**[0054]** In the illustrated example, an intensity pattern (Talbot image) of an array of focal spots **135** is repeated at a plane **136** at a distance,  $L$ , from the outer surface **133(a)** of the

aperture layer **133**. In the example, the distance,  $L$ , is an integer multiple of a half Talbot distance ( $l_{t2}$ ),  $nl_{t2}$ , from the outer surface **133(a)** of the aperture layer **133**.  $n$  can be any suitable integer value (1, 2, 3, 4, etc.). The half Talbot distance,  $l_{t2}$ , can be calculated as  $d^2/\lambda$ , where  $\lambda$  is the wavelength of the incident light field at the Talbot element **130**. In the example, the array of focal spots **135** is a two-dimensional array with dimensions of  $5 \times 5$  and with 25 focal spots **135(a)**. The array of focal spots **135** includes an X-axis and Y-axis (not shown). The X-axis and Y-axis lie in the plane **136** at a distance,  $L$ , from the outer surface **133(a)** of the aperture layer **133**. Although the focal spots **135(a)** are illustrated in the form of a circular spot, the focal spots **135(a)** may be of any suitable form.

[0055] During the image acquisition process, the two-axis MEMS mirror **121** can change the phase gradient incident on the Talbot element **130** over time and in both directions by changing the mechanical tilt angles:  $\beta_x$  and  $\beta_y$  **121(b)**. Tilting the two-axis MEMS mirror **121** induces a change of the optical tilt angles  $\theta_x$  and  $\theta_y$ , which induces a phase gradient change,  $k_x$  and  $k_y$ , at the Talbot element **130**. The phase gradient change at the Talbot element **130** induces a translational movement of the array of focal spots **135**, which is the Talbot image of the aperture array **134**. A small linear phase gradient change at the Talbot element **130** may induce a relatively large lateral translational shift of the Talbot image of the array of focal spots **135**. The translational shift in the X-direction can be calculated as  $\Delta X = L_n \times \tan(\theta_x) \approx L_n \times \theta_x = L_n \times 2 \times \beta_x$ , where  $\theta_x$  is the optical tilt angle in the  $x'$ -tilt direction and  $L_n$  is the integer multiple of the half Talbot distance,  $L_n = n\lambda^2/d$ , ( $n$  is integer). The translational shift in the Y-direction can be calculated as  $\Delta Y = L_n \times \tan(\theta_y) \approx L_n \times \theta_y = L_n \times 2 \times \beta_y$ , where  $\theta_y$  is the optical tilt angle in the  $y'$ -tilt direction. To move the array of focal spots **135** by a distance of one period,  $d$ , of the Talbot element **130** in either direction, the phase gradient change needs to be  $k = \lambda/(nd)$ , corresponding to the MEMS mirror **121** mechanical tilt angle of  $\beta = \text{atan}(k)/2 \approx \lambda/(2 \times nd)$ . In order to achieve a full field scan of the array of focal spots **135** in both lateral directions X and Y at the plane **136**, the MEMS mirror **121** may change the mechanical tilt angles,  $\beta_y$  and  $\beta_x$ , by at least  $\lambda/(2 \times nd)$ . For example, to full field scan the array of focal spots **135** at a plane **136** at a Talbot distance ( $n = 2$ ), if the distance between the microlens  $d_l = 30$  microns and the wavelength of the incident light  $\lambda = 488$  nm, then the mechanical tilt angle  $\beta$  of the MEMS mirror **121** in each direction only needs to be:  $\beta = 488\text{nm}/(2 \times 2 \times 30 \text{ um})\text{rad} = 0.0041\text{rad} = 0.23\text{degree}$ .

[0056] In FIG. 2, the Ti device **100** also includes a collection element **140** and a light detector **150**. The light detector **150** is in the form of a layer having an imaging sensor (e.g.,

a CMOS imaging sensor). The collection element **140** is in the form of a layer (e.g., coating) of a fluorescence filter material over the light detector **150**. The fluorescence filter material can reject (e.g., absorb, reflect, etc.) excitation wavelength and transmit emission wavelength.

[0057] In **FIG. 2**, the specimen surface **160** is an outer surface of the collection element **140** in the illustrated example. In other embodiments, the specimen surface **160** may be a surface of a transparent layer located over the light detector **150** or may be another suitable surface. In some cases, the specimen surface **160** may be located so that an object **300** being imaged can be located on the specimen surface **160** and lie at the plane **136** at an integer multiple of a half Talbot distance ( $l_{t/2}$ ),  $nl_{t/2}$ , from the outer surface **133(a)**.

[0058] In **FIG. 2**, an object **300** (e.g., cell) being imaged by the Ti system **10** is located on the specimen surface **160** and at the plane **136** of the array of focal spots **135** at a distance,  $L$ , from the outer surface **133(a)**. In the illustrated example, the distance,  $L_n$ , may be an integer multiple of a half Talbot distance ( $l_{t/2}$ ),  $nl_{t/2}$ , where  $n$  can be any suitable integer value (1, 2, 3, 4, etc.). Although a single object **300** is shown, any suitable number of objects **300** may be imaged by the Ti system **10** of embodiments.

[0059] In an exemplary fluorescence imaging operation of the Ti system **10** of **FIG. 2**, an object **300** with activated fluorophores is provided on the specimen surface **160** so that the plane **136** lies through a portion of the object **300**. The fluorophores may have been activated in a separate operation using a dye that marks or tags portions of the object **300** (e.g., cell nucleus) under investigation with fluorophore(s). The plane **136** is located at a distance of an integer multiple of a half Talbot distance,  $nl_{t/2}$  ( $n=1, 2, 3$ , etc.) away from the Talbot element **130**. The processor **210** (shown in **FIG. 1**) sends a first trigger signal to the phase gradient generating device **120** to start phase generating and a second trigger signal to the light detector **150** to start image acquisition. The light source **110** provides coherent light **112** in the form of a collimated linear polarized beam incident on the polarization sensitive beam splitter **124** in response to receiving a start signal from the phase gradient generating device **120** or other component of the Ti system **10**, or from being initiated by a user of the Ti system **10**.

[0060] In response to receiving the first trigger signal, the MEMS mirror **121** of the phase gradient generating device **120** begins incrementally changing the mechanical tilt angles,  $\beta_x$  and  $\beta_y$  in the x'-direction and/or y' direction over time to scan the array of focal spots **135**. Any suitable increments,  $\beta_i$ , can be used to increase/decrease the mechanical tilt

angles. In some cases, the increments used may be selected based on the resolution desired or based on the desired image acquisition speed. In one case, to maximally exploit the resolution limited by the sharpness of Talbot focal spot **135(a)**, the mechanical tilt angle increment  $\beta_i = \Delta/2L_n$  is used, where  $\Delta$  is the full-width-at-half-maximum of Talbot focal spot **135(a)**. In another case, a finer increment  $\beta_i < \Delta/2L_n$  can be applied, but the image resolution may not be improved. In another case, coarser increments can be used to increase image acquisition speed.

[0061] As the array of focal spots **135** is scanned over the object **300**, the focal spots **136** provide excitation light of specific wavelength(s) at the location of the focal spots **135(a)**. Focal spots **135(a)** can locally excite activated fluorophores in the object **300** at the location of the focal spots **135(a)**. In response to receiving the excitation light, the activated fluorophores at the location of the focal spots **135(a)** re-emit light at a different wavelength(s). The collection element **140** receives the excitation light and emissions from the excited fluorophores. The collection element **140** rejects (e.g., absorbs, reflects, etc.) the excitation light and passes the emissions to the light detector **150**. As the array of focal spots **135** is scanned at the plane **136**, the light detector **150** receives the emissions passed by the collection element **140** and records time varying light data (e.g., intensity data) of the emissions. The time varying data collected corresponds the emissions collected based on the locally activated fluorophores at the locations of the individual focal spots **135(a)**. Since the fluorophores are activated locally at the location of the scanning focal spots **135(a)**, the resolution of the Ti system **10** may be based on the focus quality of the Talbot image (i.e., the array of focal spots **135**) and not on the pixel size of the imaging sensor used. While changing the phase gradient of the beam, the fluorescence intensity of individual focal spots **135(a)** on the light detector **150** is locally collected. The intensity information associated with the foci positions can be used to form a two-dimensional image. The size (e.g., pixel size) of the light detecting element **152** (as shown in **FIG. 5**) of the light detector **150** (e.g., CMOS imaging sensor) should be smaller than the distance between the focal spots **135(a)** in the array so that the emission intensity from different focal spots **135(a)** can be differentiated.

[0062] After the light detector **150** completes the acquisition cycle, it sends a handshake signal to the processor **210**. The processor **210** sends a stop signal to the phase gradient generating device **120** and the phase gradient generating device **120** stops phase generating. The processor **210** receives a signal or signals with the time varying light data from the image sensor **150** and constructs one or more bright field and/or fluorescence

images of the object **300** based on the time varying light data and other data received. The processor **210** can display the one or more images on the display **230**.

[0063] In one embodiment, the filter layer **140** may be omitted or the filter layer **140** may not reject the wavelength of the incident light to the Talbot element **130**. In this embodiment, the Ti system **10** of the first configuration can be used for bright field imaging.

[0064] **B. CONFIGURATION 2**

[0065] **FIG. 3** is a side view of components and partial components of a Ti system **10** of a second configuration, according to embodiments of the invention. The Ti system **10** of the illustrated example may be used for bright field imaging and/or may be fabricated on a chip. In **FIG. 3**, the Ti system **10** of the second configuration includes a Ti device **100** and a computing device **200** (shown in **FIG. 1**) in communication with the Ti device **100**.

[0066] In **FIG. 3**, the Ti device **100** includes a light source **110** providing coherent light **112**, a phase gradient generating device **120**, and a Talbot element **130**. The light source **110** provides coherent light **112** in the form of a collimated linear polarized beam incident on the phase gradient generating device **120**. The phase gradient generating device **120** is in the form of a liquid crystal beam deflector. Any suitable liquid crystal beam deflector can be used. Some examples of suitable liquid crystal beam deflectors include a liquid crystal wedge and a liquid crystal blazed grating. Although the phase gradient generating device **120** is shown located proximal the Talbot element **130**, in other embodiments, a transparent layer (e.g., microlens array layer) may lie between the Talbot element **130** and the phase gradient generating device **120**.

[0067] The Ti device **100** includes a Talbot element **130** includes an aperture layer **133** having a two-dimensional aperture array **134** and an outer surface **133(a)**. **FIG. 3** illustrates a portion of the Talbot element **130**. The entire Talbot element **130** is a two-dimensional aperture array **134** having dimensions of any suitable size any suitable size (e.g.,  $30 \times 30$ ,  $100 \times 100$ ,  $200 \times 200$ ,  $100 \times 300$ ,  $200 \times 400$ ,  $400 \times 400$ , etc.). In other embodiments, the aperture array **134** may be one-dimensional arrays having dimensions of suitable sizes (e.g.,  $100 \times 1$ ,  $200 \times 1$ ,  $300 \times 1$ , etc.). The illustrated portion of the Talbot element **130** includes a two dimensional array having dimensions with a size of  $5 \times 5$ , and includes 25 apertures **134(a)** (shown in **FIG. 2**).

[0068] The two-dimensional aperture array **134** of the Talbot element **130** includes apertures **134(a)** (as shown in FIG. 2) with a uniform circular shape and a uniform diameter of 0.6 micron. In other embodiments, the apertures **134(a)** may have other suitable shapes and sizes (e.g., 0.2 micron, 0.5 micron, 1 micron, 2 microns, etc.). The aperture size may affect focus quality in some cases.

[0069] In FIG. 3, the Talbot element **130** has a period,  $d$ , which corresponds to the period of the two-dimensional aperture array **134**. The period,  $d$ , may be any suitable value (e.g., 5 microns, 15 microns, 30 microns, 100 microns, etc.).

[0070] In the illustrated example, an intensity pattern (Talbot image) of an array of focal spots **135** is generated at a plane **136** at a distance,  $L$ , from the outer surface **133(a)** of the aperture layer **133**. The distance,  $L$ , is an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$ , from the outer surface **133(a)** of the aperture layer **133**.  $n$  can be any suitable integer value (1, 2, 3, 4, etc.). The half Talbot distance,  $l_{t,2}$ , can be calculated as  $d^2/\lambda$ , where  $\lambda$  is the wavelength of the incident light field at the Talbot element **130**. In this example, the array of focal spots **135** is a two-dimensional array with dimensions of  $5 \times 5$  and with 25 focal spots **135(a)**. The array of focal spots **135** includes an X-axis and Y-axis (not shown). The X-axis and Y-axis lie in the plane **136** at a distance,  $L$ , from the outer surface **133(a)** of the aperture layer **133**. Although the focal spots **135(a)** are illustrated in the form of a circular spot, the focal spots **135(a)** may be of any suitable form.

[0071] In FIG. 3, the Ti device **100** also includes a light detector **150** for receiving/measuring light data, and a specimen surface **160** for receiving objects **300** being imaged by the Ti system **10**. The light detector **150** is in the form of an imaging sensor (e.g., a CMOS imaging sensor). The specimen surface **160** is the outer surface of the light detector **150** in the illustrated example. In other embodiments, the specimen surface **160** may be a surface of a transparent layer (e.g., protective layer) or a filter layer **150** (shown in FIG. 2) located over the light detector **150** or may be another suitable surface. In some cases, the specimen surface **160** or Talbot element **130** may be adjusted (e.g., relocated) so that an object **300** being imaged can be at the plane **136** at an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$ , from the outer surface **133(a)**.

[0072] In FIG. 3, three objects **300** (e.g., cells) being imaged by the Ti system **10** are located on the specimen surface **160** and at the plane **136** of the array of focal spots **135** at a distance,  $L$ , from the outer surface **133(a)**. The distance,  $L$ , is an integer multiple of a half

Talbot distance ( $l_{t2}$ ),  $nl_{t2}$ , where  $n$  can be any suitable integer value (1, 2, 3, 4, etc.).

Although three objects **300** are shown, any suitable number (e.g., 1, 2, 3, 4, 10, 20, 100) of objects **300** may be imaged by the Ti system **10** of embodiments.

[0073] In this second configuration illustrated in **FIG. 3**, the liquid crystal beam deflector controls the phase gradient of the incident beam to the Talbot element **130**. By deflecting the incident beam through liquid crystal beam deflector, the two-dimensional array of focal spots **135** of the Talbot image can be scanned over the objects **300** being imaged. If a focal spot **135(a)** moves to a location during scanning where an object **300** is scatterous or absorptive, the light will be altered and the intensity readout of the light detecting elements **152** (as shown in **FIG. 5**) in the light detector **150** underneath the focal spot **135(a)** will decrease. Without a collection element **140**, a bright field image can be constructed by the Ti system **10** in **FIG. 3**. If a collection element **140** comprising a filter layer is placed between the specimen surface **160** and the light detector **150** in the Ti device **100** in **FIG. 3**, the Ti system **10** of the second configuration can be used for fluorescence imaging as well.

[0074] In an exemplary bright field imaging operation of the Ti system **10** of **FIG. 3**, objects **300** are provided on the specimen surface **160** so that the plane **136** lies through a portion of the objects **300**. The plane **136** is located at a distance of an integer multiple of a half Talbot distance,  $nl_{t2}$  ( $n=1, 2, 3$ , etc.) away from the Talbot element **130**. The processor **210** (shown in **FIG. 1**) sends a first trigger signal to the phase gradient generating device **120** to start phase generating and a second trigger signal to the light detector **150** to start image acquisition. The light source **110** provides coherent light **112** in the form of a collimated linear polarized beam incident on the liquid crystal beam deflector in response to receiving a start signal from the phase gradient generating device **120** or other component of the Ti system **10**, or from being initiated by a user of the Ti system **10**.

[0075] In response to receiving the first trigger signal, liquid crystal beam deflector begins changing the phase gradient of the incident beam on the Talbot element **130**. The liquid crystal beam deflector changes the phase gradient from 0 to  $k$  to scan the array of focal spots **135** from 0 to  $nl_{t2} \times k$  in both the X and Y directions at the plane **136** over the objects **300**.

[0076] As the array of focal spots **135** is scanned over the objects **300**, the objects **300** alter the light from the scanning array of focal spots **135**. As the array of focal spots **135** is scanned over the objects **300**, the light detector **150** receives altered and unaltered light

and records time varying light data (e.g., intensity data). After the light detector **150** completes the acquisition cycle, it sends a handshake signal to the processor **210**. The processor **210** sends a stop signal to the phase gradient generating device **120** and the phase gradient generating device **120** stops phase generating. The processor **210** receives a signal or signals with the time varying light data from the light detector **150** and constructs one or more bright field images of the objects **150** based on the time varying light data. The processor **210** can display the one or more images on the display **230**.

**[0077] C. CONFIGURATION 3**

**[0078] FIG. 4** is a side view of components and partial components of a Ti system **10** of a third configuration, according to embodiments of the invention. The Ti system **10** of the illustrated example may be used for bright field and/or fluorescence imaging. The Ti system **10** of the illustrated example may be fabricated on a chip. In **FIG. 4**, the Ti system **10** of the third configuration includes a Ti device **100** and a computing device **200** (shown in **FIG.1**) in communication with the Ti device **100**.

**[0079]** In **FIG. 4**, the Ti device **100** includes a light source **110** providing coherent light **112** in the form of a collimated beam. In this configuration, the Ti device **100** also includes a micro-concave mirror array **126** mounted on a piezo tilt stage **125** that serves as both a phase gradient generating device **120** and a Talbot element **130**. **FIG. 4** illustrates a portion of the micro-concave mirror array **126**. The Ti device **100** also includes a light detector **150** and a specimen surface **160** for receiving an object **300** being imaged by the Ti system **10**. The Ti device **100** also includes a beam splitter **170** for reflecting the collimated beam from the light source **110** to the micro-concave mirror array **126**. The micro-concave mirror array **126** focuses the light to repeat a Talbot image of an array of focal spots **135**. Compared with a micro lens, a concave mirror has the advantage of being able to achieve a high numerical aperture, and thus a tighter focus, as described in Merenda, F., Rohner, J., Fournier, J. M. and Salath, R. P. "Miniaturized high-NA focusing-mirror multiple optical tweezers," Optics Express 15, 6075-6086 (2007), which is hereby incorporated by reference in its entirety for all purposes.

**[0080]** The micro-concave mirror array **126** includes an x'-axis and y'-axis (not shown). The x'-axis and y'-axis lie in a plane through the center of the foci of the micro-concave mirror array **126**. The micro-concave mirror array **126** can be tilted by a mechanical tilt angle,  $\beta_x$ , (not shown) in the x'-tilt direction and a mechanical tilt angle,  $\beta_y$ , **121(b)** in the

y'-tilt direction **121(b)**. In the illustrated example, the piezo tilt stage **125** can tilt (rotate) the micro-concave mirror array **126** along the x'-axis and y'-axis to change the  $\beta_x$  and  $\beta_y$  respectively. In the illustrated example, the micro-concave mirror array **126** is mounted on a piezo tilt stage **125** that can be tilted around two axels to rotate the micro-concave mirror array **126** along the x'-axis and y'-axis to change the  $\beta_x$  and  $\beta_y$  respectively.

[0081] During an image acquisition process, the piezo tilt stage **125** can tilt the micro-concave mirror array **126** to change the phase gradient over time. Changing the mechanical tilt angles,  $\beta_x$  and  $\beta_y$  of the micro-concave mirror array **126** induces a respective change in the optical tilt angles,  $\theta_x$  and  $\theta_y$ , of the incident field to the Talbot element **130**. A change in the optical tilt angles,  $\theta_x$  and  $\theta_y$ , induces a respective change of the phase gradient  $k_x$  and  $k_y$ , of the incident field to the Talbot element **130**. The relationships are described in Eqns. 1a, 1b, 1c, and 1d. The phase gradient change at the Talbot element **130** induces a translational movement of the array of focal spots **135**. A translational shift in the X-direction can be calculated as  $\Delta X = L_n \times \tan(\theta_x) \approx L_n \times \theta_x = L_n \times 2 \times \beta_x$ , where  $\theta_x$  is the optical tilt angle in the x'-tilt direction and  $L_n$  is the integer multiple of the half Talbot distance,  $L_n = n\lambda^2/d$ , (n is integer). The translational shift in the Y-direction can be calculated as  $\Delta Y = L_n \times \tan(\theta_y) \approx L_n \times \theta_y = L_n \times 2 \times \beta_y$ , where  $\theta_y$  is the optical tilt angle in the y'-tilt direction. To move the array of focal spots **135** by a distance of one period,  $d$ , of the Talbot element **130** in either direction, the phase gradient change needs to be  $k = \lambda/(nd)$ , corresponding the mechanical tilt angle of  $\beta = \arctan(k)/2 \approx \lambda/(2 \times nd)$ . In order to achieve a full field scan of the array of focal spots **135** in both lateral directions X and Y at the plane **136**, the micro-concave mirror array **126** may change the mechanical tilt angles,  $\beta_y$  and  $\beta_x$ , by at least  $\lambda/(2 \times nd)$ .

[0082] The Ti device **100** includes a micro-concave mirror array **126**. The micro-concave mirror array **126** is a two-dimensional array having dimensions of any suitable size (e.g.,  $30 \times 30$ ,  $100 \times 100$ ,  $200 \times 200$ ,  $100 \times 300$ ,  $200 \times 400$ ,  $400 \times 400$ , etc.). In other embodiments, the micro-concave mirror array **126** may be one-dimensional array having dimensions of a suitable size (e.g.,  $100 \times 1$ ,  $200 \times 1$ ,  $300 \times 1$ , etc.). **FIG. 4** illustrates a portion of the entire micro-concave mirror array **126**. The illustrated portion of the micro-concave mirror array **126** is a two-dimensional array with dimension of a size of  $8 \times 8$ , and having 64 micro concave mirrors **126(a)**.

[0083] Each micro-concave mirror **126(a)** in the micro-concave mirror array **126** may have any properties (e.g., size, concavity, reflectivity, etc.) of any suitable value. In the

illustrated example, the micro-concave mirror array **126** and associated Talbot element **130** have a period,  $d$ , of 30 microns. In other embodiments, the period of the Talbot element **130**,  $d$ , may have other suitable values such as 5 microns, 15 microns, 100 microns, etc.

[0084] In **FIG. 4**, the light source **110** provides coherent light **112** incident the beam splitter **170**. The beam splitter **170** reflects the beam to the micro-concave mirror array **126**. The micro-concave mirror array **126** reflects and focuses the beam. The intensity pattern (Talbot image) of an array of focal spots **135** is generated at a distance,  $L_n$ , from a plane through the center of the foci of the micro-concave mirror array **126**. In the example, the distance,  $L_n$ , is an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$ , from the micro-concave mirror array **126**.  $n$  can be any suitable integer value (1, 2, 3, 4, etc.). The half Talbot distance,  $l_{t,2}$ , can be calculated as  $d^2/\lambda$ , where  $\lambda$  is the wavelength of the incident light field at the Talbot element **130**.

[0085] **FIG. 4** illustrates a portion of the array of focal spots **135** of a two-dimensional array with dimensions having a size of  $5 \times 5$ , with 25 focal spots **135(a)**. The entire array of focal spots **135** may have a dimensions of any suitable size (e.g.,  $30 \times 30$ ,  $10 \times 10$ ,  $30 \times 10$ ,  $100 \times 100$ , etc.). The array of focal spots **135** includes an X-axis and Y-axis (not shown). The X-axis and Y-axis lie in the plane **136** at a distance,  $L_n$ , from plane through the center of the foci of the micro-concave mirror array **126**. Although the focal spots **135(a)** are illustrated in the form of a circular spot, the focal spots **135(a)** may be of any suitable form.

[0086] In **FIG. 4**, the Ti device **100** also includes a light detector **150** for receiving/measuring light data, and a specimen surface **160** for receiving an object **300** being imaged by the Ti system **10**. The light detector **150** is in the form of a layer having an imaging sensor (e.g., a CMOS imaging sensor). The specimen surface **160** is an outer surface of the light detector **150** in the illustrated example. In other embodiments, the specimen surface **160** may be a surface of a transparent layer or a filter layer **150** (shown in **FIG. 2**) located over the light detector **150** or may be another suitable surface. In some cases, the specimen surface **160** may be located so that an object **300** being imaged can be located on the specimen surface **160** and lie at the plane **136** at an integer multiple of a half Talbot distance ( $l_{t,2}$ ),  $nl_{t,2}$  from the plane through the center of the foci of the micro-concave mirror array **126**.

[0087] If a focal spot **135(a)** moves to a location during scanning where the object **300** is scatterous or absorptive, the light will be altered and the intensity readout of the light

detecting elements **152** (as shown in **FIG. 5**) in the light detector **150** underneath the focal spot **135(a)** will decrease. Without a collection element **140** having a filter, a bright field image can be constructed by the Ti system **10** in **FIG. 4**. If a collection element **140** comprising a filter layer is placed between the specimen surface **160** and the light detector **150** in the Ti device **100** in **FIG. 4**, the Ti system **10** of the third configuration can be used for fluorescence imaging and/or bright-field imaging.

[0088] In **FIG. 4**, an object **300** (e.g., cell) being imaged by the Ti system **10** is located on the specimen surface **160** and at a plane **136** of the array of focal spots **135** at a distance,  $L$ , from the plane through the center of the foci of the micro-concave mirror array **126**. In the illustrated example, the distance,  $L$ , may be an integer multiple of a half Talbot distance ( $l_{t/2}$ ),  $nl_{t/2}$ , where  $n$  can be any suitable integer value (1, 2, 3, 4, etc.). Although a single object **300** is shown, any suitable number of objects **300** may be imaged by the Ti system **10** of embodiments.

[0089] In an exemplary imaging operation of the Ti system **10** of **FIG. 4**, an object **300** being imaged is provided on the specimen surface **160**. The plane **136** lies through a portion of the object **300**. The plane **136** is located at a distance of an integer multiple of a half Talbot distance,  $nl_{t/2}$  ( $n=1, 2, 3$ , etc.) away from the Talbot element **130**. The processor **210** (shown in **FIG. 1**) sends a first trigger signal to the piezo tilt stage **125** to start phase generating and a second trigger signal to the light detector **150** to start image acquisition. The light source **110** provides coherent light **112** incident on the beam splitter **170** in response to receiving a start signal from the phase gradient generating device **120** or other component of the Ti system **10**, or from being initiated by a user of the Ti system **10**.

[0090] In response to receiving the first trigger signal, the piezo tilt stage **125** begins incrementally changing the mechanical tilt angles,  $\beta_x$  and  $\beta_y$  in the x'-direction and/or y' direction over time to scan the array of focal spots **135**. Any suitable increments,  $\beta_i$ , can be used to increase/decrease the mechanical tilt angles. In some cases, the increments used may be selected based on the resolution desired or based on the desired image acquisition speed. In one case, to maximally exploit the resolution limited by the sharpness of Talbot focal spot **135(a)**, the mechanical tilt angle increment  $\beta_i = \Delta/2L_n$  is used, where  $\Delta$  is the full-width-at-half-maximum of Talbot focal spot **135(a)**. In another case, a finer increment  $\beta_i < \Delta/2L_n$  can be applied, but the image resolution may not be improved. In another case, coarser increments can be used to increase image acquisition speed.

[0091] As the array of focal spots **135** scans over the object **300**, the object **300** alters the light from the scanning array of focal spots **135**. As the array of focal spots **135** is scanned over the object **300**, the light detector **150** receives altered and unaltered light and records time varying light data (e.g., intensity data). As the array of focal spots **135** is scanned over the object **300**, the optical signal collected by the light detector **150** underneath the object **300** may include any suitable light data associated with the altered light such as scattering intensity, fluorescent intensity, polarization, etc. In one case, the Ti device **100** includes a collection element **140** between the specimen surface **160** and the light detector **150**. The collection element **140** includes a polarizer. In this case, the optical signal includes the polarization change by the object **300**.

[0092] After the light detector **150** completes the acquisition cycle, it sends a handshake signal to the processor **210**. The processor **210** sends a stop signal to the piezo tilt stage **125** and the piezo tilt stage **125** stops phase generating. The processor **210** receives a signal or signals with the time varying light data from the light detector **150** and constructs one or more images of the objects **150** based on the time varying light data. The processor **210** can display the one or more images on the display **230**.

[0093] Modifications, additions, or omissions may be made to the Ti device **100** and/or Ti system **10** of embodiments without departing from the scope of the disclosure. For example, a Ti device **100** and/or Ti system **10** of embodiments may omit the light source **110** as a component. Instead, the light source **110** may be a separate component from the Ti device **100** and/or Ti system **10**. As another example, a Ti device **100** and/or Ti system **10** may omit or add a collection element **140**.

[0094] In addition, components of the Ti device **100** and/or Ti system **10** of embodiments may be integrated or separated according to particular needs. For example, the processor **210** may be integrated into the light detector **150** so that the light detector **150** performs one or more of the functions of the processor **210** in another Ti system **10**. As another example, the processor **210**, CRM **220**, and display **230** may be components of a computer separate from a Ti system **10** and in communication with the Ti system **10**. As another example, the processor **210**, second CRM **220**, and/or display **230** may be integrated into components of the Ti device **100**.

[0095] In some embodiments, the Ti device **100** and/or Ti system **10** may be added to other components to provide combined functionality. For example, the Ti device **100** and/or

Ti system **10** may be combined with a microfluidic device to form an integrated imaging and diagnosis system. Some other examples may be combining the Ti device **100** and/or Ti system **10** with a micro-well array for single cell imaging, on-chip cell culture, microfluidic cell sorting, enzyme-linked immunosorbent assay (ELISA), etc..

**[0096] II. Exemplary Readout and Reconstruction Methods**

**[0097]** The light detector **150** of the Ti system **10** can use a data acquisition readout method to collect the light data (optical information) of interest on a time-varying basis from each scanning focal spot **135(a)** as it is scanned at a plane **136** over a scanning region of the light detector **150**. The time-varying light data of interest is associated with light altered by an object **300** located at the plane **136**. With a reconstruction method, the processor **210** of the Ti system **10** can use the time-varying light data to generate an image of the object **300**. This section describes two exemplary readout and reconstruction methods that can be used by Ti systems **10** of embodiments. In the first example, the readout and reconstruction method is based on a direct readout mode. In the second example, the readout and reconstruction method is based on a monitored readout mode.

**[0098] A. Direct Readout Mode**

**[0099]** In a direct readout mode, the light detector **150** and the scanning range of the array of focal spot **135** are aligned so that each focal spot **135(a)** scans over a predefined scanning region **154** of the light detector **150**. In this mode, the total scanning range of the array of focal spots **135** covers about the entire region of the light detector **150** being used to image the object **300**. Since the predefined scanning regions **154** do not overlap with other, the readout from each predefined scanning region **154** directly corresponds to the light data (optical information) at each focal spot **135(a)**. That is, the time varying light data measured by the light detecting elements **152** in each predefined scanning region **154** directly corresponds to the location and other properties of a single corresponding focal spot **135(a)**. Each predefined scanning region **154** may include any suitable number (e.g., 1, 2, 4, 16, 64, etc.) of light detecting elements **152**. Each predefined scanning regions **152** may be in the form of a one-dimensional or two-dimensional array of light detecting elements **152**.

**[0100]** **FIG. 5** is a sensor floor plan **400** used in a direct readout mode, according to an embodiment of the invention. A sensor floor plan **400** is a plan view diagram of a light detector **150** and corresponding focal spots **135(a)**. The sensor floor plan **400** can define the readout correspondence between regions of the light detector **150** and the focal spots **135(a)**.

[0101] In **FIG. 5**, the sensor floor plan **400** includes a light detector **150** of a Ti device **100** of an embodiment. The Ti device **100** can be of any configuration. The light detector **150** includes a two-dimensional array of light detecting elements **152**. The two-dimensional array has dimensions of a size of  $8 \times 8$ , and includes 64 light detecting elements **152**. In other embodiments, the light detector **150** may have dimensions of other suitable sizes (e.g.,  $100 \times 1$ ,  $30 \times 30$ ,  $100 \times 300$ ,  $2048 \times 1680$ , etc.). The sensor floor plan **400** also illustrates a two-dimensional array of focal spots **135** located over the light detector **150**. The two-dimensional array has dimensions of a size of  $2 \times 2$ , and includes four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)**. In other embodiments, the array of focal spots **135** may have dimensions of other suitable sizes.

[0102] The sensor floor plan **400** defines four predefined scanning regions **154(1)**, **154(2)**, **154(3)**, and **154(4)** of the light detector **150**, corresponding to the four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)**, respectively. Each predefined scanning region includes a  $4 \times 4$  two-dimensional array of light detecting elements **152**.

[0103] **FIG. 6** is a reconstruction schematic used in a direct readout mode, according to an embodiment of the invention. In this schematic, the light detector **150** includes a two-dimensional array of light detecting elements **152**. The two-dimensional array has dimensions of a size of  $4 \times 4$ , and includes 16 light detecting elements **152**. In this schematic, the light detector **150** includes four predefined scanning regions **154(1)**, **154(2)**, **154(3)**, and **154(4)** corresponding to the four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)**, respectively. Each predefined scanning region includes a  $2 \times 2$  two-dimensional array of light detecting elements **152**.

[0104] In the schematic, the four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)** scan an object **300** on top of the four predefined scanning regions **154(1)**, **154(2)**, **154(3)**, and **154(4)** of the light detector **150**. As the focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)** scan the object **300**, the light detector **150** records a sequence (time varying light data) of intensity or other light property associated with the focal spots **135(a)** at each position of the focal spots **135(a)**.

[0105] The processor **210** of the Ti system **10** uses the time varying light data at each position of the focal spot **135(a)** in each predefined scanning region **154** to reconstruct an image with the size equal to the predefined scanning region **154**. The full field-of-view image is constructed by combining the images from all the predefined scanning regions **154**.

[0106] In an embodiment of the Ti system **10** in the direct readout mode, binning of the light detecting elements **152** (e.g., pixels) within a predefined scanning region **154** can be done to increase the readout speed of the light detector **150**. Binning of the light detecting elements **152** may improve acquisition speed.

[0107] **B. Monitored Readout Mode**

[0108] In a monitored readout mode, the light detector **150** and the scanning range of the array of focal spots **135** do not need to be strictly aligned. In this mode, the light detector **150** includes a calibration region **155** for monitoring the location of the scanning focal spots **135(a)** during scanning. The calibration region **155** does not have an object **300** over it during acquisition. In some cases, a physical barrier may be located between the calibration region **155** and other region of the light detector **150**. The calibration region **155** may include any suitable number (e.g., 1, 2, 4, 16, 64, etc.) of light detecting elements **152**.

[0109] **FIG. 7** is a sensor floor plan **400** used in a monitored readout mode, according to an embodiment of the invention. The sensor floor plan **400** can define the readout correspondence between light detecting elements **152** of the light detector **150** and the focal spots **135(a)**.

[0110] In **FIG. 5**, the sensor floor plan **400** includes a light detector **150** of a Ti device **100** of an embodiment. The Ti device **100** can be of any configuration. The light detector **150** includes a two-dimensional array of light detecting elements **152**. The two-dimensional array has dimensions of a size of  $8 \times 8$ , and includes 64 light detecting elements **152**. In other embodiments, the light detector **150** may have dimensions of other suitable sizes (e.g.,  $100 \times 1$ ,  $30 \times 30$ ,  $100 \times 300$ ,  $2048 \times 1680$ , etc.). The sensor floor plan **400** also illustrates a two-dimensional array of focal spots **135** located over the light detector **150**. The two-dimensional array has dimensions of a size of  $2 \times 2$ , and includes four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)**. In other embodiments, the array of focal spots **135** may have dimensions of other suitable sizes.

[0111] The sensor floor plan **400** defines a calibration region **155** of the light detector **150** corresponding to the focal spot **135(a)(3)**. In the illustrated example, the calibration region **155** includes a two-dimensional array with dimensions of  $4 \times 4$ , and including 16 light detecting elements **152(a)**. The calibration region **155** does not have an object **300** over it during acquisition and does not have a collection element over it. The light detector **150** also includes a region of 48 light detecting elements **152(b)** outside the calibration region **155**.

[0112] Since the calibration region **155** is associated with the focal spot **135(a)(3)** and there is known distance between the focal spots **135** in the array of focal spots **135**, locations of all the other focal spots **135(a)** in the array **135** can be calculated based on the location of the focal spot **135(a)(3)**. This readout mode does not require strict alignment between the Talbot element **130** and the light detector **150** and also allows overlap of the scanning regions of the different focal spots **135(a)**.

[0113] **FIG. 8** is a reconstruction schematic used in a monitored readout mode, according to an embodiment of the invention. In **FIG. 8**, a portion of the light detector **150** is shown that does not include the calibration region **155**. The portion of the light detector **150** shown includes a two-dimensional array of light detecting elements **152(b)** outside the calibration region **155**. The two-dimensional array has dimensions of a size of  $4 \times 4$ , and includes 16 light detecting elements **152**.

[0114] In the schematic, the four focal spots **135(a)(1)**, **135(a)(2)**, **135(a)(3)**, and **135(a)(4)** scan an object **300** on top of light detector **150**. The scanning regions scanned by neighboring focal spots **135(a)** is overlapping in overlapping regions. The overlapping regions refer to regions illuminated by neighboring focal spots **135(a)** more than once (multiple illuminations/scans) during an acquisition process. At each sample time during an acquisition process, the location of the focal spots **135(a)** can be determined by the processor **210** based on the readout from the calibration region **155**. At each sample time, the light detecting elements **152(b)** in the region outside the calibration region **155** record a sequence (time varying light data) of intensity or other light property associated with the focal spots **135(a)**. At each sample time, only the readout from the light detecting elements **152(b)** under the determined location of each focal spot **135(a)** may be used by the processor **210** to generate an image of the scanned region in some cases. The processor **210** can reconstruct a full field-of-view image from the images of the scanned regions. The processor **210** may determine the overlapping region intensity by calculated the average intensity of each of the multiple scans by the different focal spots **135(a)**. That is, since the light detected in the overlapping regions is the sum of the intensities from the multiple illuminations, to make the intensity proportional to the intensity in the non-overlapping region, the processor **210** divides the intensity in the overlapping regions by the number of overlaps (i.e. number of scans/illuminations).

[0115] **III. Flowchart**

[0116] **FIG. 9** is a flow chart of an exemplary method of operation of a Ti system **10**, according to embodiments of the invention. The Ti system **10** can be of any configuration.

[0117] In **step 510**, the object **300** is introduced into the Ti device **100** onto the specimen surface **160** of the Ti device **100**. The object **300** is located at a plane **136** that is at a distance,  $L_n$ , away from the Talbot element **130**.  $L_n$  is an integer multiple of a half Talbot distance:  $nl_{t/2}$ , where  $n$  is an integer and  $nl_{t/2}$  is the half Talbot distance. In the case of a square grid patterned Talbot element,  $L_n = nd^2/\lambda$ , where  $d$  is the period of the Talbot element **130** and  $\lambda$  is the wavelength of the incident light on the Talbot element **130**. The value of  $n$  depends on the location of the plane **136**. For example, if the plane **136** is located at a Talbot distance ( $l_t$ ) away from the Talbot element **130**, then  $n = 2$ .

[0118] In **step 520**, the acquisition process is initiated. The processor **210** sends a first trigger signal to the phase gradient generating device **120** to start phase generating and a second trigger signal to the light detector **150** to start image acquisition. At or before initiation of the acquisition process, the light source **100** begins providing a spatially coherent incident light **112** to the phase gradient generating device **120**.

[0119] In **step 530**, the phase gradient generating device **120** incrementally changes the phase gradient of the light field incident a Talbot element **130** in order to scan the Talbot image (e.g., an array of focal spots **135**) at the plane **136** over the object **300**. For example, the phase gradient generating device **120** may sweep the phase gradient in two orthogonal directions to scan the Talbot image at the plane **136**. Any suitable increments can be used. In order to achieve a full field scan of the Talbot image in both lateral directions X and Y at the plane **136**, the phase gradient change in both directions must be  $k = \lambda/(nd)$ . In **step 540**, as the Talbot image is scanned over the object **300**, the object **300** alters the light.

[0120] In **step 550**, the collection element **140** collects and/or differentiates the light of interest from the light received. For example, the collection element **140** may include a filter for passing emissions and rejecting excitation light. In this example, the Ti system **10** may be used for fluorescence imaging. As another example, the collection element **140** may include a polarizer. In this case, the optical signal Ti system **10** may be used for polarization imaging. In other embodiments, the Ti system **10** may not include a collection element **140**. The light detector **140** receives the light of interest collected/differentiated by the collection element **140**.

[0121] In step **560**, the light detector **150** captures time varying light data as the Talbot image is scanned. After the light detector **150** completes the acquisition cycle, it sends a handshake signal to the processor **210**. The processor **210** sends a stop signal to the phase gradient generating device **120** and the phase gradient generating device **120** stops phase generating.

[0122] In step **570**, processor **210** receives a signal or signals with the time varying light data from the light detector **150** and constructs one or more images of the object **300**. Either the direct readout mode or the monitored readout mode can be used to readout the time varying light data and construct the one or more images of the object **300**. The processor **210** can display the one or more images on the display **230**.

[0123] **IV. Subsystems**

[0124] **FIG. 10** is a block diagram of subsystems that may be present in the Ti system **10**, according to embodiments of the invention. For example, the Ti system **10** includes a processor **210**. The processor **210** may be a component of the light detector **150** in some cases.

[0125] The various components previously described in the Figures may operate using one or more of the subsystems to facilitate the functions described herein. Any of the components in the Figures may use any suitable number of subsystems to facilitate the functions described herein. Examples of such subsystems and/or components are shown in a **FIG. 10**. The subsystems shown in **FIG. 10** are interconnected via a system bus **425**. Additional subsystems such as a printer **430**, keyboard **432**, fixed disk **434** (or other memory comprising computer readable media), display **230**, which is coupled to display adapter **438**, and others are shown. The display **230** may include the illuminating display **116** and/or the image display **230**. Peripherals and input/output (I/O) devices, which couple to I/O controller **440**, can be connected to the computer system by any number of means known in the art, such as serial port **442**. For example, serial port **442** or external interface **444** can be used to connect the computer apparatus to a wide area network such as the Internet, a mouse input device, or a scanner. The interconnection via system bus allows the processor **210** to communicate with each subsystem and to control the execution of instructions from system memory **446** or the fixed disk **434**, as well as the exchange of information between subsystems. The system memory **446** and/or the fixed disk **434** may embody a CRM **220**. Any of these elements may be present in the previously described features.

[0126] In some embodiments, an output device such as the printer 430 or display 230 of the Ti system 10 can output various forms of data. For example, the Ti system 10 can output 2D/3D HR color/monochromatic images, data associated with these images, or other data associated with analyses performed by the Ti system 10.

[0127] It should be understood that the present invention as described above can be implemented in the form of control logic using computer software in a modular or integrated manner. Based on the disclosure and teachings provided herein, a person of ordinary skill in the art will know and appreciate other ways and/or methods to implement the present invention using hardware and a combination of hardware and software.

[0128] Any of the software components or functions described in this application, may be implemented as software code to be executed by a processor using any suitable computer language such as, for example, Java, C++ or Perl using, for example, conventional or object-oriented techniques. The software code may be stored as a series of instructions, or commands on a CRM, such as a random access memory (RAM), a read only memory (ROM), a magnetic medium such as a hard-drive or a floppy disk, or an optical medium such as a CD-ROM. Any such CRM may reside on or within a single computational apparatus, and may be present on or within different computational apparatuses within a system or network.

[0129] A recitation of “a”, “an” or “the” is intended to mean “one or more” unless specifically indicated to the contrary.

[0130] The above description is illustrative and is not restrictive. Many variations of the disclosure will become apparent to those skilled in the art upon review of the disclosure. The scope of the disclosure should, therefore, be determined not with reference to the above description, but instead should be determined with reference to the pending claims along with their full scope or equivalents.

[0131] One or more features from any embodiment may be combined with one or more features of any other embodiment without departing from the scope of the disclosure. Further, modifications, additions, or omissions may be made to any embodiment without departing from the scope of the disclosure. The components of any embodiment may be integrated or separated according to particular needs without departing from the scope of the disclosure.

**[0132]** All patents, patent applications, publications, and descriptions mentioned above are hereby incorporated by reference in their entirety for all purposes. None is admitted to be prior art.

## WHAT IS CLAIMED IS:

1. A Talbot imaging device comprising:  
a Talbot element configured to repeat a Talbot image at a distance from the Talbot element; and  
a phase gradient generating device configured to scan the Talbot image by incrementally changing a phase gradient of a light field incident the Talbot element.
2. The Talbot imaging device of claim 1, wherein the distance is an integer multiple of a half Talbot distance.
3. The Talbot imaging device of claim 1, wherein the Talbot image is an array of focal spots.
4. The Talbot imaging device of claim 1, further comprising a light detector configured to capture time-varying light data associated with light altered by an object located at the distance from the Talbot element.
5. The Talbot imaging device of claim 4, further comprising a processor configured to construct an image of the object based on the time-varying light data.
6. The Talbot imaging device of claim 4, further comprising a collection element located between the Talbot element and the light detector, the collection element configured to pass emissions and reject excitation light to the light detector.
7. The Talbot imaging device of claim 4, wherein the phase gradient generating device scans the Talbot image in lateral directions of a plane at the distance by incrementally changing the phase gradient in two orthogonal directions.
8. The Talbot imaging device of claim 4, wherein the Talbot element comprises a two-dimensional array of apertures.
9. The Talbot imaging device of claim 1, wherein the phase gradient generating device comprises a liquid crystal beam deflector.

10. The Talbot imaging device of claim 1, wherein the phase gradient generating device comprises a MEMS mirror.
11. A Talbot imaging system comprising:  
a Talbot imaging device comprising  
a Talbot element configured to repeat a Talbot image at a distance from the Talbot element, and  
a phase gradient generating device configured to scan the Talbot image by incrementally changing a phase gradient of a light field incident the Talbot element, and  
a light detector configured to capture time-varying light data associated with light altered by an object located at the distance from the Talbot element; and  
a processor configured to construct an image of the object based on the time-varying light data.
12. The Talbot imaging system of claim 11, wherein the distance is an integer multiple of a half Talbot distance.
13. The Talbot imaging device of claim 11, wherein the Talbot image is an array of focal spots.
14. The Talbot imaging system of claim 11, further comprising a collection element located between the Talbot element and the light detector, the collection element configured to pass emissions and reject excitation light to the light detector.
15. The Talbot imaging device of claim 11, wherein the phase gradient generating device scans the Talbot image in lateral directions of a plane at the distance by incrementally changing the phase gradient in two orthogonal directions.
16. A method of imaging using a Talbot imaging system, the method comprising:  
incrementally changing a phase gradient of a light field incident a Talbot element to scan a Talbot image at a plane at a distance from the Talbot element;  
receives light altered by an object located at the plane;

generating, by the light detector, time varying light data based on light received; and

constructing an image of the object based on the time varying light data.

17. The method of claim 16, wherein the distance is an integer multiple of a half Talbot distance.

18. The method of claim 16, wherein the Talbot image is an array of focal spots.

19. The method of claim 16, wherein the Talbot image is scanned in two orthogonal directions of the plane.

20. The method of claim 16, further comprising filtering light to the light detector.

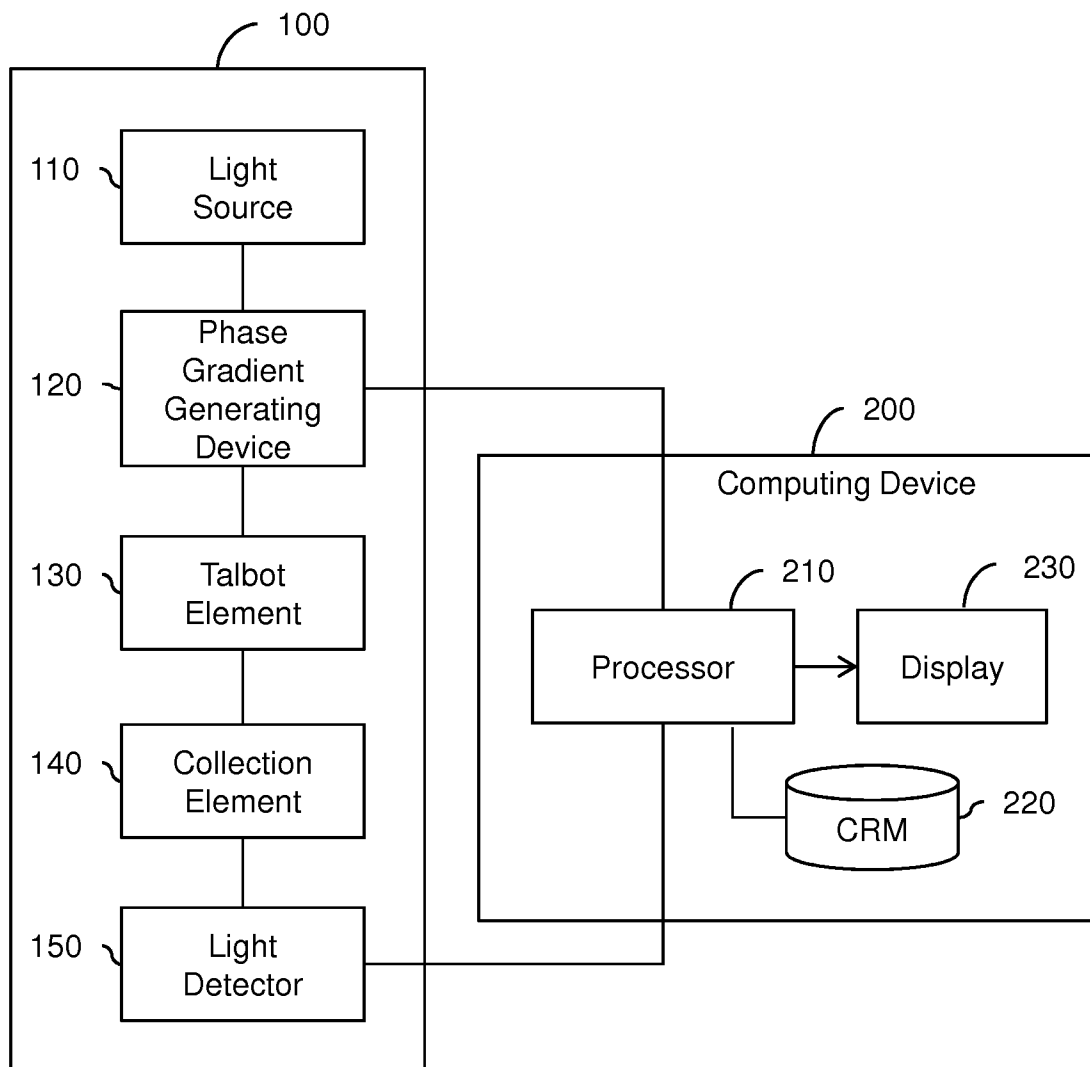
10

FIG. 1

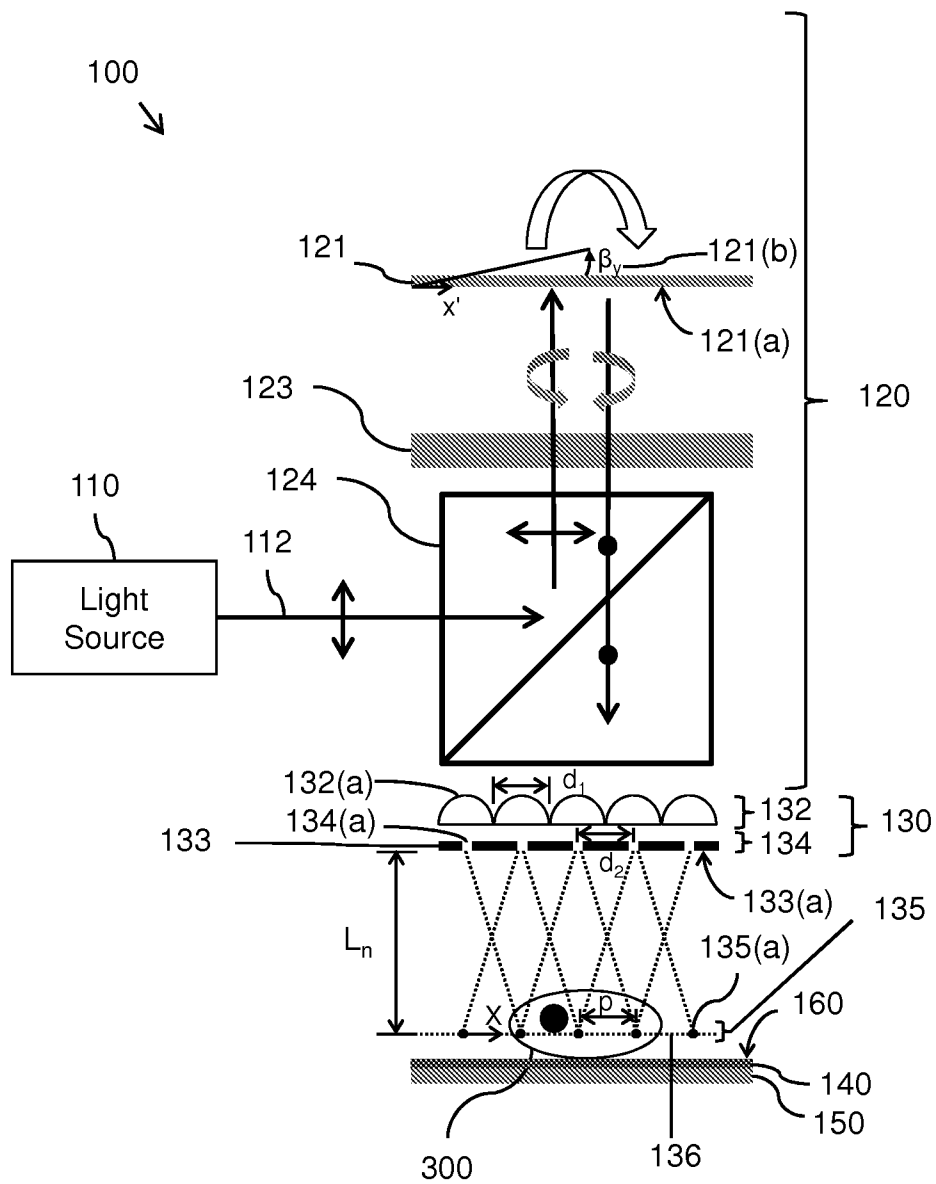


FIG. 2

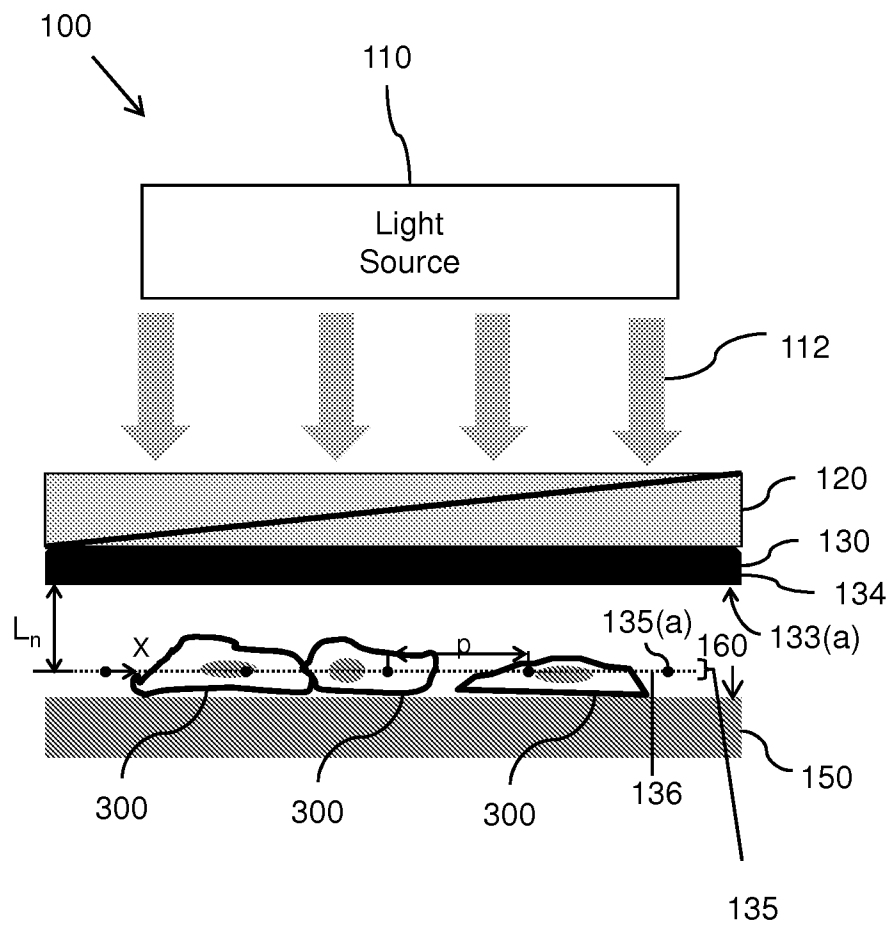


FIG. 3

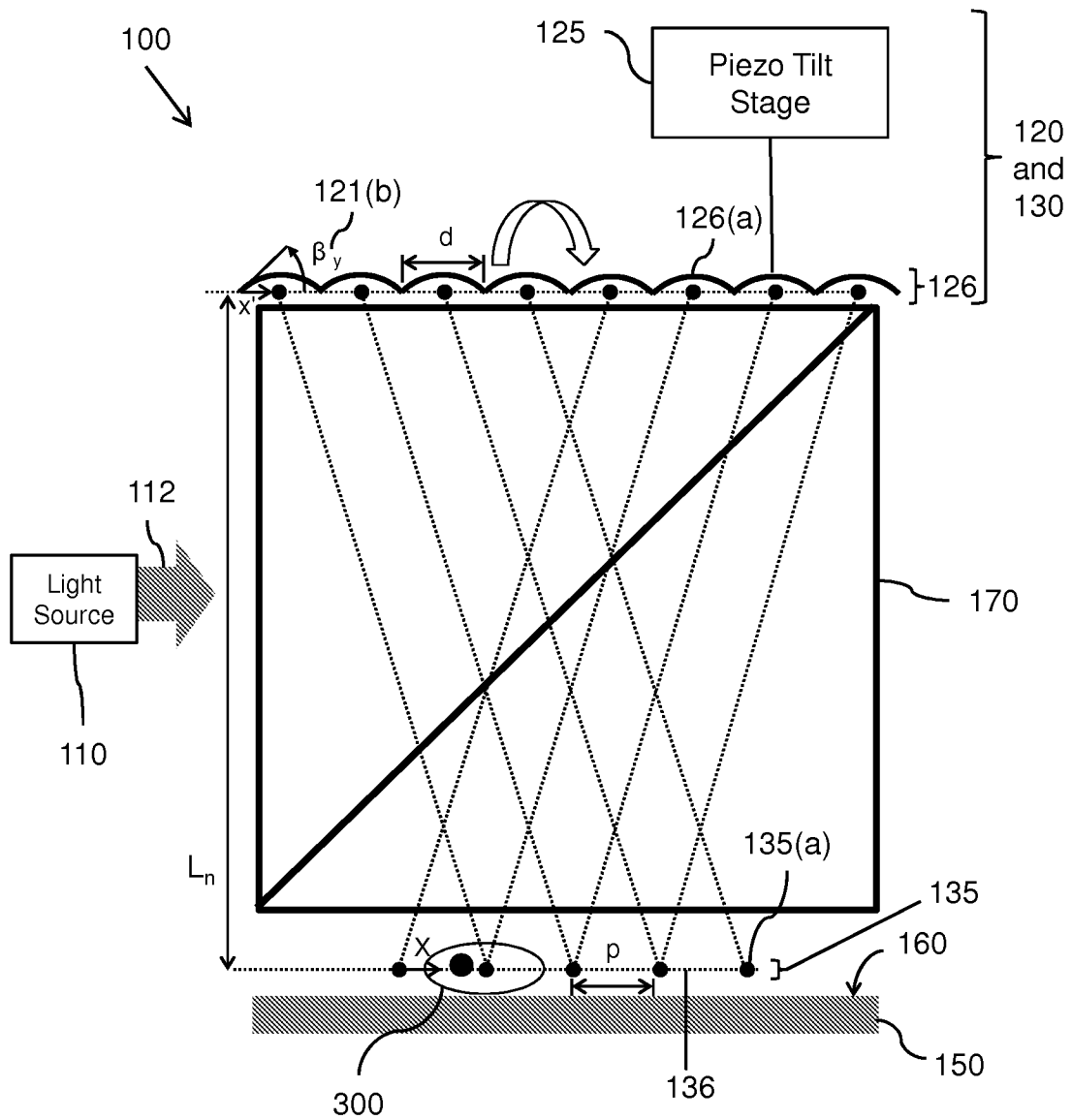


FIG. 4

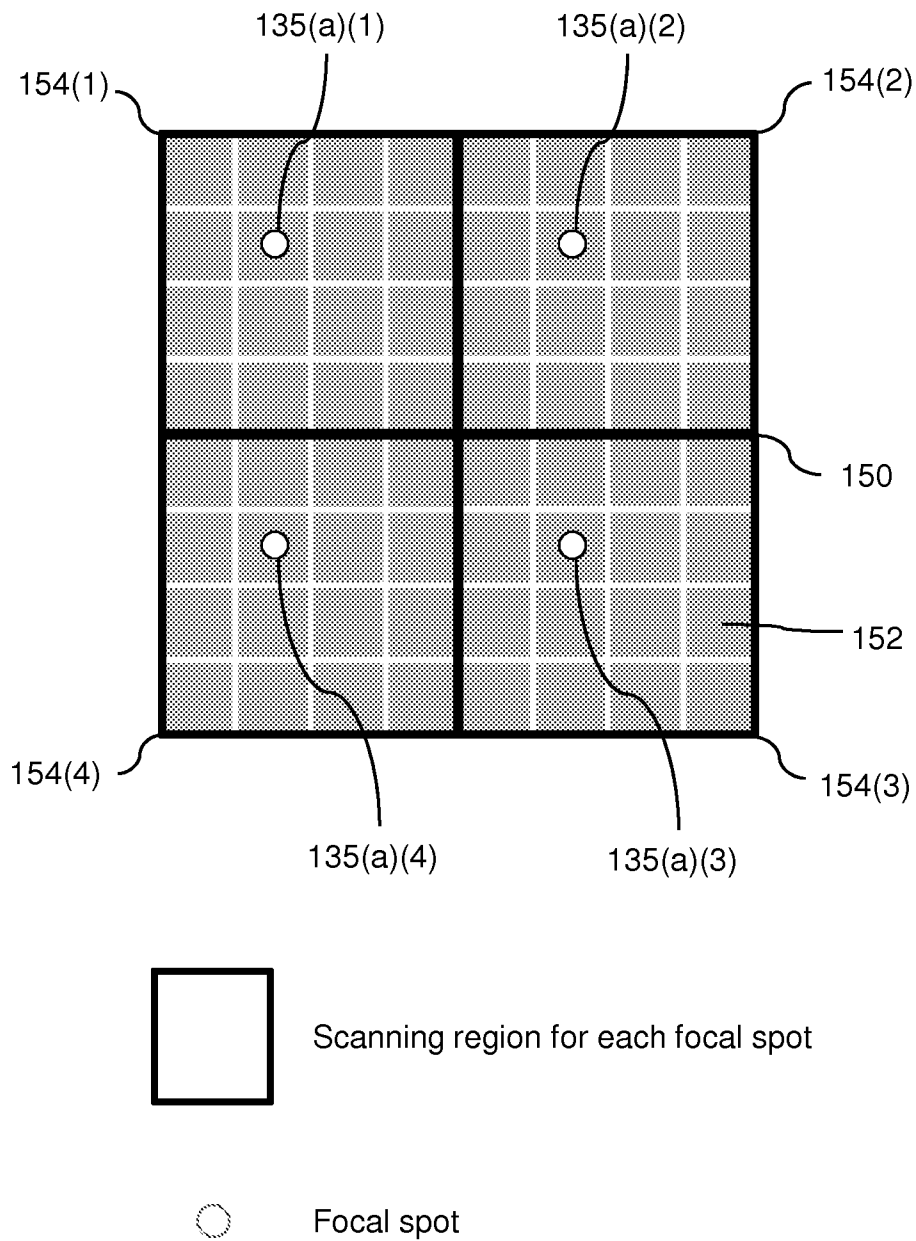
400

FIG. 5

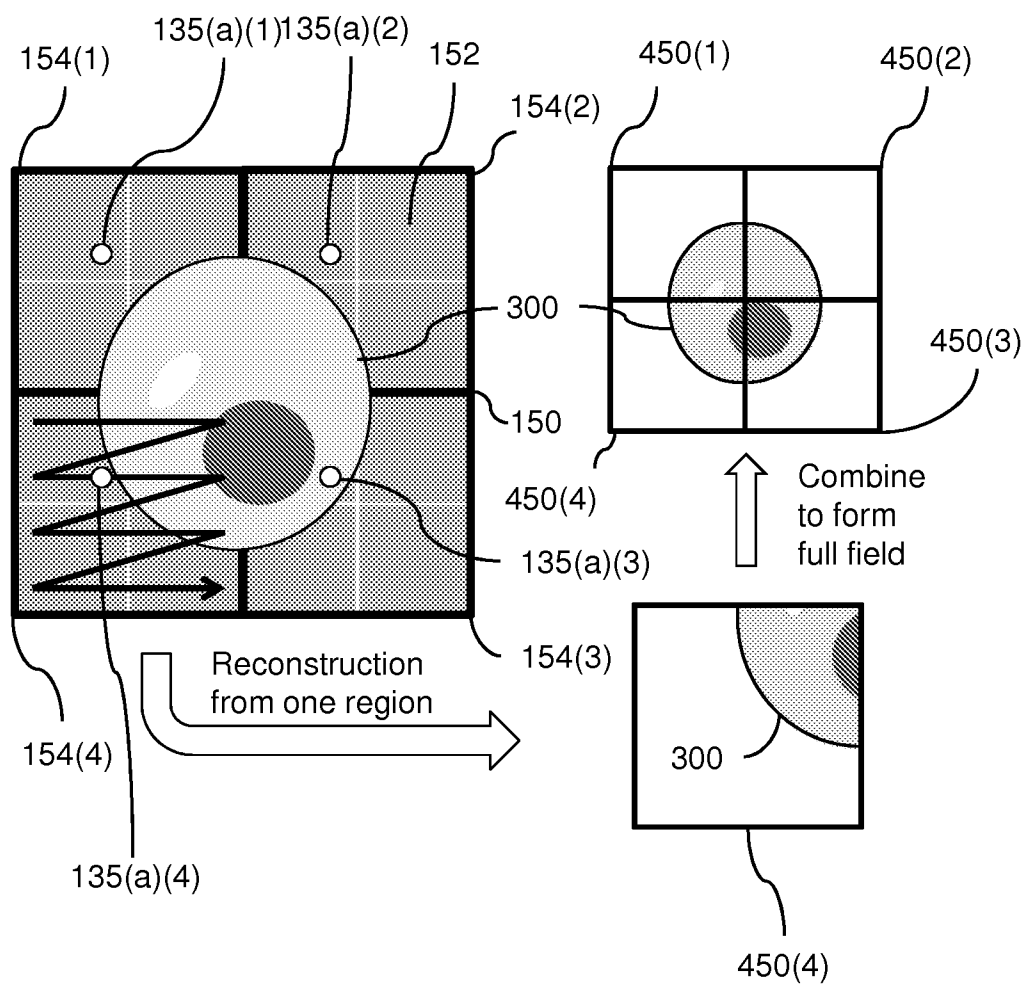
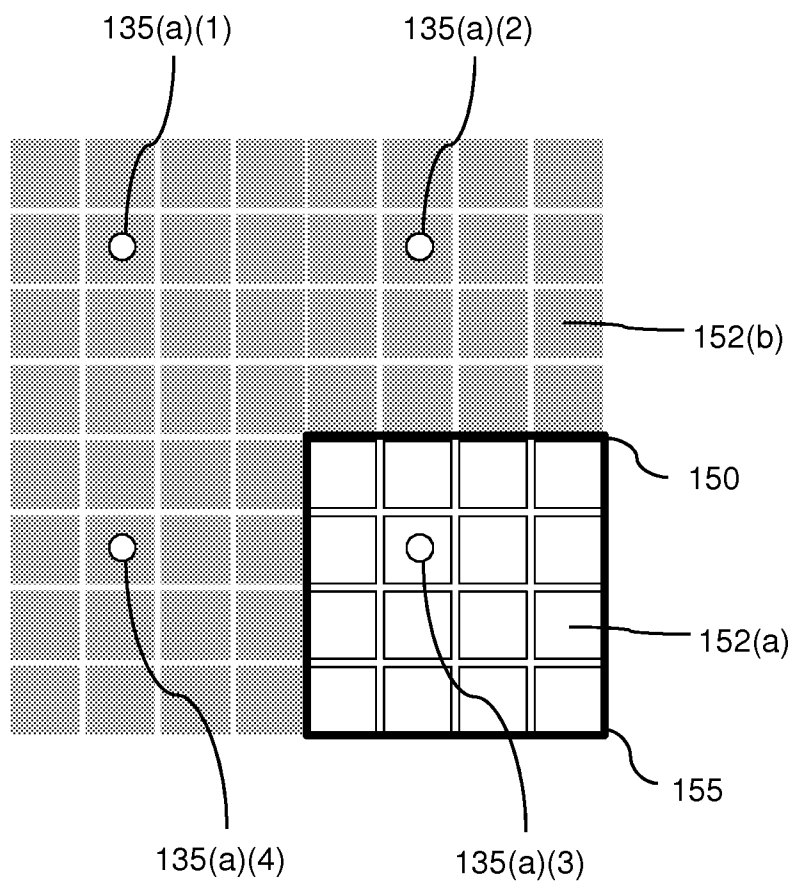


FIG. 6

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400

Pixels filled with sample and/or collection element



Bare pixels for calibration purpose



The focal spot

FIG. 7

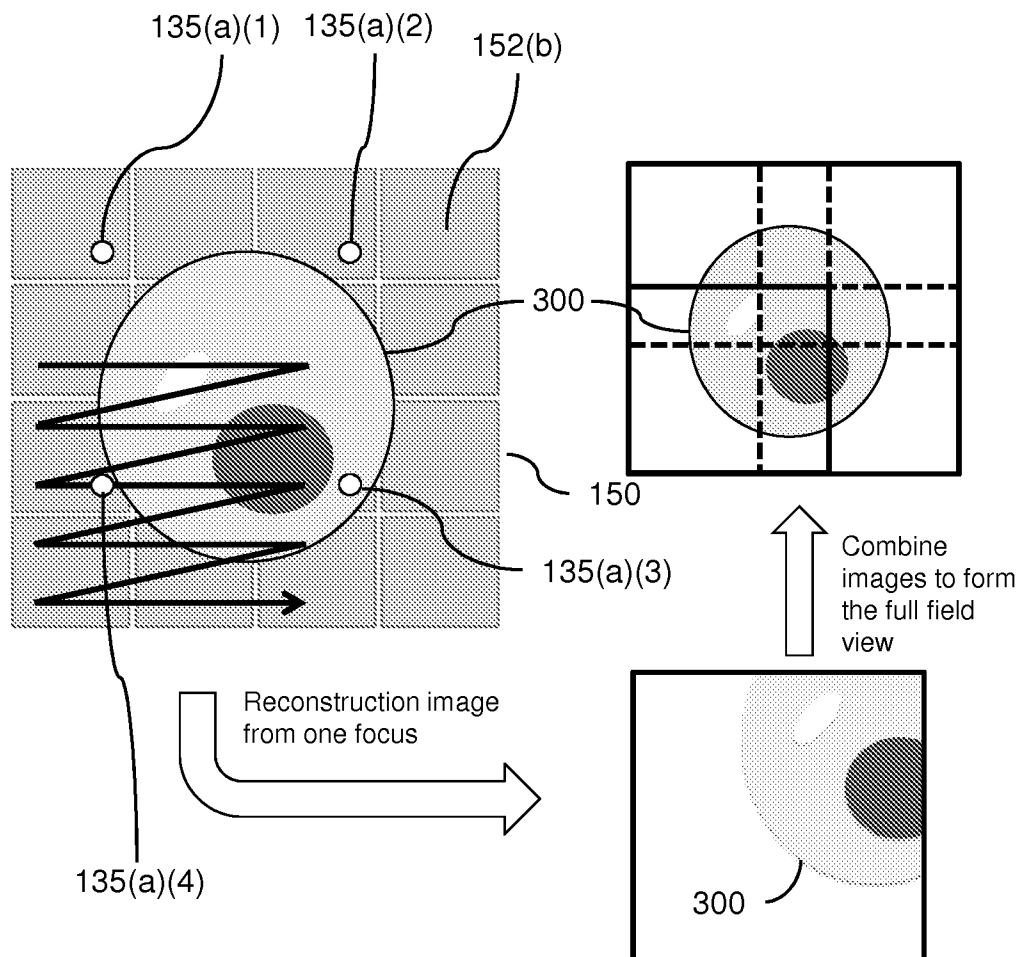


FIG. 8

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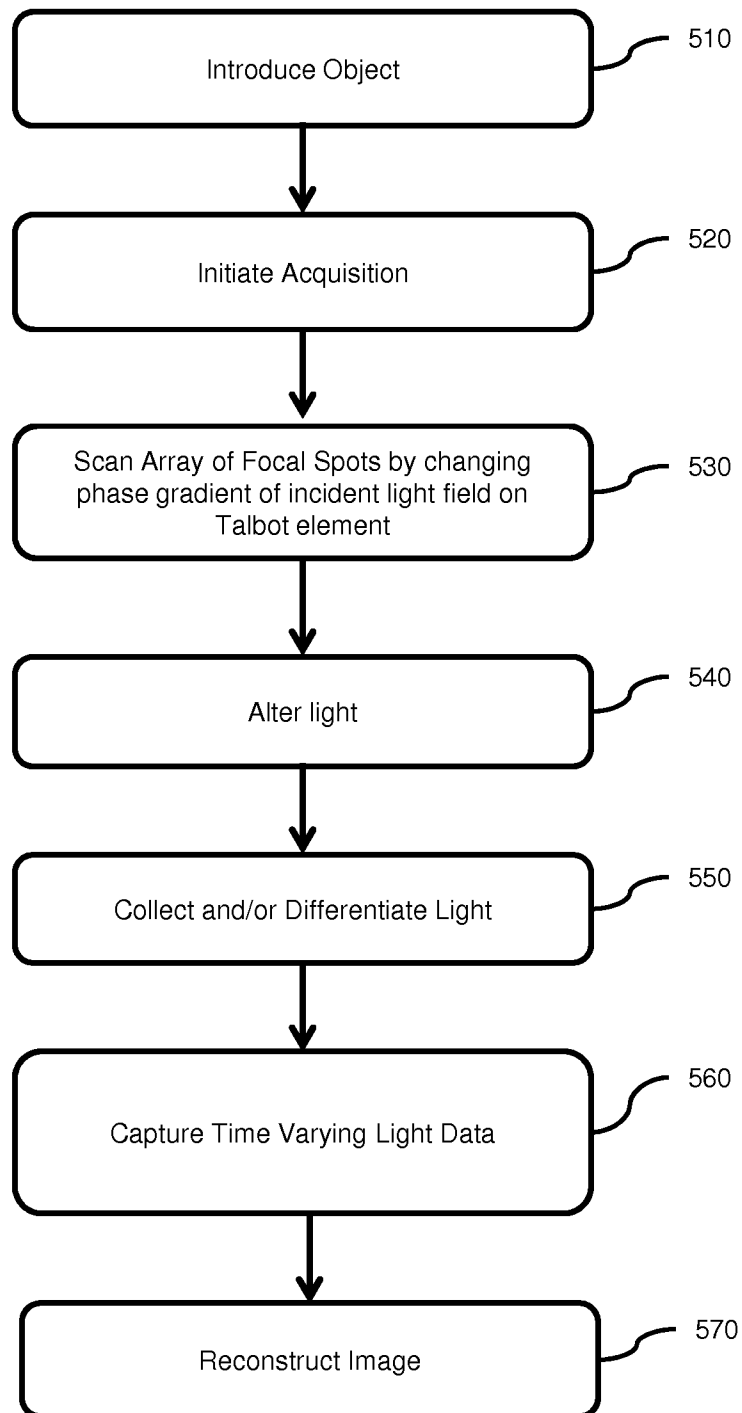


FIG. 9

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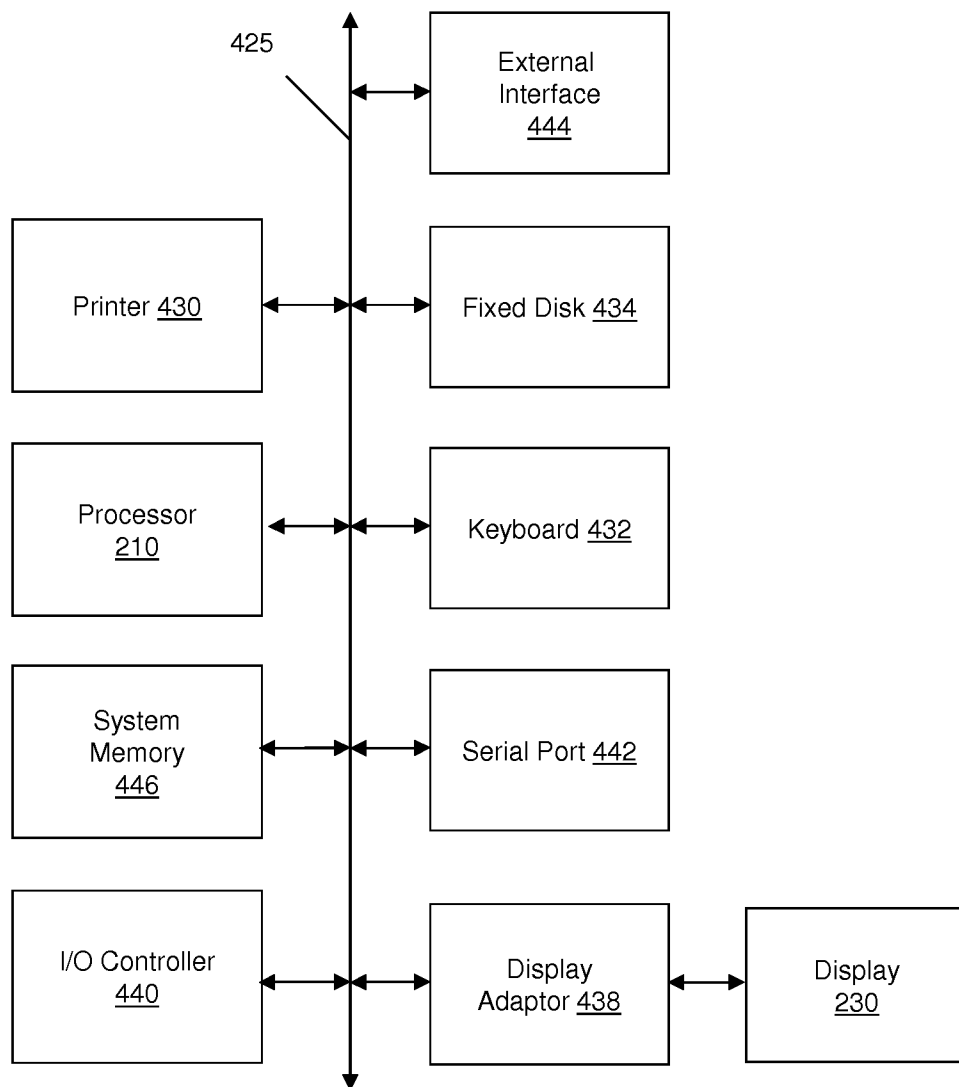


FIG. 10